











DLP470TP
DLPS105A – JANUARY 2018 – REVISED MAY 2018

## **DLP470TP 0.47 4K UHD DMD**

#### 1 Features

- 0.47-Inch Diagonal Micromirror Array
  - 4K UHD (3840 x 2160) Display Resolution
  - 5.4-µm Micromirror Pitch
  - ±17° Micromirror Tilt (Relative to Flat Surface)
  - Bottom Illumination
- · 2xLVDS Input Data Bus
- Supports 4K UHD at 60 Hz and Full HD at 240 Hz
- LED Operation Supported by Two Dedicated DLPC6421 Display Controllers, DLPA3005 Power Management IC (PMIC), and LED Driver

## 2 Applications

- Mobile Smart TV
- Mobile Projector
- Digital Signage
- Commercial Gaming
- Smart Home Displays
- Mobile Home Cinema

## 3 Description

The DLP470TP digital micromirror device (DMD) is a digitally controlled micro-electromechanical system (MEMS) spatial light modulator (SLM) that enables bright 4K UHD display systems. The DLP® 0.47" 4K UHD chipset is composed of the DLP470TP DMD, two DLPC6421 display controllers, and DLPA3005 PMIC and LED driver. The compact physical size of the chipset provides a complete system solution that enables small form factor 4K UHD displays.

The DLP470TP ecosystem includes established resources to help the user accelerate the design cycle, which include production ready optical modules, optical module manufacturers, and design houses.

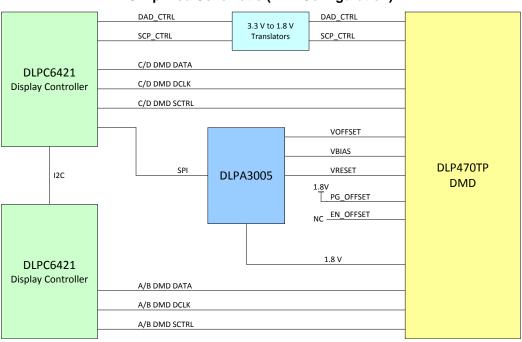
Visit the Getting Started with TI DLP Pico™ display technology page to learn more about how to start designing with the DLP470TP DMD.

#### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE   | BODY SIZE (NOM)    |
|-------------|-----------|--------------------|
| DLP470TP    | FQN (250) | 25.65 mm × 16.9 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## Simplified Schematic (LED Configuration)





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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

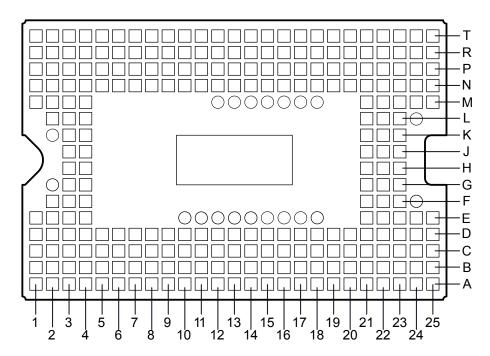
## Changes from Original (January 2018) to Revision A

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## 5 Pin Configuration and Functions

FQN Package 250-Pin CLGA Bottom View



#### **CAUTION**

Properly manage the layout and the operation of signals identified in the Pin Functions table to make sure there is reliable, long-term operation of the .47" 4K UHD S316 DMD. Refer to the *PCB Design Requirements for TI DLP Pico TRP Digital Micromirror Devices* application report for specific details and guidelines before designing the board.



## Pin Functions<sup>(1)</sup>

| PIN      |     |                    | DATA   | INTERNAL |              | TRACE          |                 |         |  |  |         |  |         |
|----------|-----|--------------------|--------|----------|--------------|----------------|-----------------|---------|--|--|---------|--|---------|
| NAME     | NO. | I/O <sup>(2)</sup> | SIGNAL | RATE     | TERMINATION  | DESCRIPTION    | LENGTH<br>(mil) |         |  |  |         |  |         |
| D_AN(0)  | B5  |                    |        |          |              |                | 8987.47         |         |  |  |         |  |         |
| D_AN(1)  | B1  |                    |        |          |              |                | 8979.19         |         |  |  |         |  |         |
| D_AN(2)  | В3  |                    |        |          |              |                | 9213.84         |         |  |  |         |  |         |
| D_AN(3)  | F2  |                    |        |          |              |                | 9390.87         |         |  |  |         |  |         |
| D_AN(4)  | D2  |                    |        |          |              |                | 9541.45         |         |  |  |         |  |         |
| D_AN(5)  | D3  |                    |        |          |              |                | 9270.74         |         |  |  |         |  |         |
| D_AN(6)  | C7  |                    |        |          |              |                | 9020.02         |         |  |  |         |  |         |
| D_AN(7)  | В9  |                    | LVDC   | DDD      | Differential | Data na pativa | 9360.86         |         |  |  |         |  |         |
| D_AN(8)  | C9  |                    | LVDS   | DDR      | Differential | Data negative  | 9057.9          |         |  |  |         |  |         |
| D_AN(9)  | D7  |                    |        |          |              |                | 9382.75         |         |  |  |         |  |         |
| D_AN(10) | B10 | -                  |        |          |              |                |                 | 9068.69 |  |  |         |  |         |
| D_AN(11) | B13 |                    |        |          |              |                |                 | 9045.89 |  |  |         |  |         |
| D_AN(12) | C11 |                    |        |          |              |                |                 | 9466.24 |  |  |         |  |         |
| D_AN(13) | D10 |                    |        |          |              |                | 9097.42         |         |  |  |         |  |         |
| D_AN(14) | C12 |                    |        |          |              |                | 9097.42         |         |  |  |         |  |         |
| D_AN(15) | D12 |                    |        |          |              |                | 9424.03         |         |  |  |         |  |         |
| D_AP(0)  | B4  |                    | _      |          | -            | -              |                 |         |  |  |         |  | 9087.54 |
| D_AP(1)  | C1  |                    |        |          |              |                |                 |         |  |  |         |  |         |
| D_AP(2)  | B2  |                    |        |          |              |                |                 |         |  |  | 9314.29 |  |         |
| D_AP(3)  | F3  |                    |        |          |              |                |                 |         |  |  | 9504.25 |  |         |
| D_AP(4)  | E2  |                    |        |          |              |                |                 |         |  |  | 9658.59 |  |         |
| D_AP(5)  | D4  |                    |        |          |              |                | 9364.6          |         |  |  |         |  |         |
| D_AP(6)  | C6  |                    |        |          |              |                | 9120.22         |         |  |  |         |  |         |
| D_AP(7)  | B8  | - 1                | LVDS   | DDR      | Differential | Data positive  | 9461.25         |         |  |  |         |  |         |
| D_AP(8)  | C8  | '                  | LVDS   | DDK      | Differential | Data positive  | 9158.06         |         |  |  |         |  |         |
| D_AP(9)  | D6  |                    |        |          |              |                | 9483.72         |         |  |  |         |  |         |
| D_AP(10) | B11 | -                  |        |          |              |                | 9168.7          |         |  |  |         |  |         |
| D_AP(11) | B12 |                    |        |          |              |                | 9142.77         |         |  |  |         |  |         |
| D_AP(12) | C10 |                    |        |          |              |                | 9566.6          |         |  |  |         |  |         |
| D_AP(13) | D9  |                    |        |          |              |                | 9198.38         |         |  |  |         |  |         |
| D_AP(14) | C13 |                    |        |          |              |                | 9402.91         |         |  |  |         |  |         |
| D_AP(15) | D13 |                    |        |          |              |                | 9523.21         |         |  |  |         |  |         |

<sup>(1)</sup> The .47" 4K UHD TRP 2xLVDS series 316 DMD is a component of one or more DLP chipsets. Use the .47" 4K UHD TRP 2xLVDS series 316 DMD in conjunction with other components of the applicable DLP chipset to make sure there is reliable operation. These include components that contain or implement TI DMD control technology. TI DMD control technology consists of the TI technology and devices used for operating or controlling a DLP DMD.

<sup>(2)</sup> I = Input, O = Output, P = Power, G = Ground, NC = No connect.



| PIN      |     |                    |        |              |                         |               | TRACE           |  |  |  |         |
|----------|-----|--------------------|--------|--------------|-------------------------|---------------|-----------------|--|--|--|---------|
| NAME     | NO. | I/O <sup>(2)</sup> | SIGNAL | DATA<br>RATE | INTERNAL<br>TERMINATION | DESCRIPTION   | LENGTH<br>(mil) |  |  |  |         |
| D_BN(0)  | R5  |                    |        |              |                         |               | 9106.93         |  |  |  |         |
| D_BN(1)  | R1  |                    |        |              |                         |               | 8960.73         |  |  |  |         |
| D_BN(2)  | P3  |                    |        |              |                         |               | 9107.05         |  |  |  |         |
| D_BN(3)  | T2  |                    |        |              |                         |               | 9067.95         |  |  |  |         |
| D_BN(4)  | N3  |                    |        |              |                         |               | 9480.88         |  |  |  |         |
| D_BN(5)  | N1  |                    |        |              |                         |               | 9850.03         |  |  |  |         |
| D_BN(6)  | P7  |                    |        |              |                         |               | 9062.46         |  |  |  |         |
| D_BN(7)  | R7  | 1.                 | LVDC   | DDD          | Differential            | Data repetive | 9649.53         |  |  |  |         |
| D_BN(8)  | P9  | - 1                | LVDS   | DDR          | Differential            | Data negative | 9371.31         |  |  |  |         |
| D_BN(9)  | N7  |                    |        |              |                         |               | 9405.19         |  |  |  |         |
| D_BN(10) | R10 |                    |        |              |                         |               | 9068.69         |  |  |  |         |
| D_BN(11) | R13 |                    |        |              |                         |               | 9054.9          |  |  |  |         |
| D_BN(12) | P11 |                    |        |              |                         |               | 9454.71         |  |  |  |         |
| D_BN(13) | N10 |                    |        |              |                         |               | 9097.42         |  |  |  |         |
| D_BN(14) | P12 |                    |        |              |                         |               | 9372.51         |  |  |  |         |
| D_BN(15) | N12 |                    |        |              |                         |               | 9437.45         |  |  |  |         |
| D_BP(0)  | R4  |                    |        |              |                         |               |                 |  |  |  | 9213.71 |
| D_BP(1)  | P1  |                    |        |              |                         |               | 9067.86         |  |  |  |         |
| D_BP(2)  | R3  |                    |        |              |                         |               | 9205.54         |  |  |  |         |
| D_BP(3)  | R2  |                    |        |              |                         |               | 9176.89         |  |  |  |         |
| D_BP(4)  | М3  |                    |        |              |                         |               | 9599.54         |  |  |  |         |
| D_BP(5)  | N2  |                    |        |              |                         |               | 9944.11         |  |  |  |         |
| D_BP(6)  | P6  |                    |        |              |                         |               | 9169.37         |  |  |  |         |
| D_BP(7)  | R6  | - 1                | LVDS   | DDR          | Differential            | Data manitiva | 9750.42         |  |  |  |         |
| D_BP(8)  | P8  | _ '                | LVDS   | DDK          | Dillerential            | Data positive | 9478.18         |  |  |  |         |
| D_BP(9)  | N6  |                    |        |              |                         |               | 9512.86         |  |  |  |         |
| D_BP(10) | R11 |                    |        |              |                         |               | 9161.97         |  |  |  |         |
| D_BP(11) | R12 |                    |        |              |                         |               | 9158.49         |  |  |  |         |
| D_BP(12) | P10 |                    |        |              |                         |               | 9559.89         |  |  |  |         |
| D_BP(13) | N9  |                    |        |              |                         |               | 9205.09         |  |  |  |         |
| D_BP(14) | P13 |                    |        |              |                         |               | 9466.61         |  |  |  |         |
| D_BP(15) | N13 |                    |        |              |                         |               | 9529.92         |  |  |  |         |



|          |     |                    | •       |      | ctions (cont | lindod)       |                 |
|----------|-----|--------------------|---------|------|--------------|---------------|-----------------|
| PIN      |     | I/O <sup>(2)</sup> | SIGNAL  | DATA | INTERNAL     | DESCRIPTION   | TRACE<br>LENGTH |
| NAME     | NO. |                    | OIOINAL | RATE | TERMINATION  | DESCRIPTION   | (mil)           |
| D_CN(0)  | C15 |                    |         |      |              |               | 9413.25         |
| D_CN(1)  | C16 |                    |         |      |              |               | 9034.49         |
| D_CN(2)  | D15 |                    |         |      |              |               | 9524.65         |
| D_CN(3)  | C18 |                    |         |      |              |               | 9029.15         |
| D_CN(4)  | B17 |                    |         |      |              |               | 9047.75         |
| D_CN(5)  | D18 |                    |         |      |              |               | 9029.56         |
| D_CN(6)  | B18 |                    |         |      |              |               | 9364.61         |
| D_CN(7)  | D21 | - 1                | LVDS    | DDR  | Differential | Data negative | 9027.29         |
| D_CN(8)  | C20 | '                  | LVDS    | DDK  | Dillerential | Data negative | 9114.49         |
| D_CN(9)  | B20 |                    |         |      |              |               | 9009.02         |
| D_CN(10) | C22 |                    |         |      |              |               | 9051.66         |
| D_CN(11) | C24 |                    |         |      |              |               | 8992.11         |
| D_CN(12) | B22 |                    |         |      |              |               | 9016.3          |
| D_CN(13) | A25 |                    |         |      |              |               | 9151.66         |
| D_CN(14) | D25 | 1                  |         |      |              |               | 9170.16         |
| D_CN(15) | A23 |                    |         |      |              |               | 9034.48         |
| D_CP(0)  | C14 |                    |         |      |              |               | 9505.23         |
| D_CP(1)  | C17 |                    |         |      |              |               | 9147.8          |
| D_CP(2)  | D16 |                    |         |      |              |               | 9643.83         |
| D_CP(3)  | C19 |                    |         |      |              |               | 9129.78         |
| D_CP(4)  | B16 |                    |         |      |              |               | 9134.27         |
| D_CP(5)  | D19 |                    |         |      |              |               | 9134.02         |
| D_CP(6)  | B19 |                    |         |      |              |               | 9465.07         |
| D_CP(7)  | D22 |                    | LVDS    | DDR  | Differential | Data positive | 9127.74         |
| D_CP(8)  | C21 | <u> </u>           | LVDS    | DUK  | Dinefertial  | Data positive | 9233.7          |
| D_CP(9)  | B21 |                    |         |      |              |               | 9126.11         |
| D_CP(10) | C23 |                    |         |      |              |               | 9152.86         |
| D_CP(11) | D24 |                    |         |      |              |               | 9092.44         |
| D_CP(12) | B23 |                    |         |      |              |               | 9140.94         |
| D_CP(13) | B25 |                    |         |      |              |               | 9251.97         |
| D_CP(14) | E25 |                    |         |      |              |               | 9270.5          |
| D_CP(15) | A24 |                    |         |      |              |               | 9140.97         |

Submit Documentation Feedback



| PIN DATA INTERNAL    |            |                    |        |              |                      |                         |                    |               |
|----------------------|------------|--------------------|--------|--------------|----------------------|-------------------------|--------------------|---------------|
|                      |            | I/O <sup>(2)</sup> | SIGNAL | DATA<br>RATE | INTERNAL TERMINATION | DESCRIPTION             | TRACE<br>LENGTH    |               |
| NAME                 | NO.        |                    |        | NAIL         | TERMINATION          |                         | (mil)              |               |
| D_DN(0)              | P15        |                    |        |              |                      |                         | 9391.44            |               |
| D_DN(1)              | P16        | -                  |        |              |                      |                         | 9034.49            |               |
| D_DN(2)              | N15        | -                  |        |              |                      |                         | 9480.3             |               |
| D_DN(3)              | P18        | -                  |        |              |                      |                         | 8967.95            |               |
| D_DN(4)              | R17        | -                  |        |              |                      |                         | 9047.75            |               |
| D_DN(5)              | N18        | -                  |        |              |                      |                         | 9029.56            |               |
| D_DN(6)              | R18        | -                  |        |              |                      |                         | 9364.61            |               |
| D_DN(7)              | N21        | ı                  | LVDS   | DDR          | Differential         | Data negative           | 9027.29            |               |
| D_DN(8)              | P20        | 1                  |        |              |                      |                         | 9114.49            |               |
| D_DN(9)              | R20        |                    |        |              |                      |                         | 9009.02            |               |
| D_DN(10)             | P22        |                    |        |              |                      |                         | 9037.74            |               |
| D_DN(11)             | P24        | -                  |        |              |                      |                         | 8992.11            |               |
| D_DN(12)             | R22        |                    |        |              |                      |                         | 8976.7             |               |
| D_DN(13)             | T25        |                    |        |              |                      |                         | 9133.73            |               |
| D_DN(14)             | N25        | -                  |        |              |                      |                         | 9154.85            |               |
| D_DN(15)             | T23        |                    |        |              |                      |                         | 9034.48            |               |
| D_DP(0)              | P14        | -                  |        |              |                      |                         | 9498.52            |               |
| D_DP(1)              | P17        |                    |        |              |                      |                         |                    | 9131.6        |
| D_DP(2)              | N16        |                    |        |              |                      |                         | 9606.19            |               |
| D_DP(3)              | P19        | -                  |        |              |                      |                         | 9061.86            |               |
| D_DP(4)              | R16        |                    |        |              |                      |                         | 9147.35            |               |
| D_DP(5)              | N19        |                    | LVDS   |              |                      |                         | 9127.31            |               |
| D_DP(6)              | R19        |                    |        |              |                      |                         | 9458.36            |               |
| D_DP(7)              | N22        | ı                  |        | LVDS         | LVDS DE              | DDR                     | Differential       | Data positive |
| D_DP(8)              | P21        |                    |        |              |                      |                         | 9226.99            |               |
| D_DP(9)              | R21<br>P23 |                    |        |              |                      |                         | 9119.4<br>9136.66  |               |
| D_DP(10)             |            |                    |        |              |                      |                         |                    |               |
| D_DP(11)             | N24<br>R23 |                    |        |              |                      |                         | 9085.73<br>9074.67 |               |
| D_DP(12)             | R25        |                    |        |              |                      |                         | 9227.84            |               |
| D_DP(13)<br>D_DP(14) | M25        |                    |        |              |                      |                         | 9260.64            |               |
| D_DP(15)             | T24        |                    |        |              |                      |                         | 9140.37            |               |
|                      | E4         | I                  | LVDS   | DDR          | Differential         | Serial control negative | 9444.29            |               |
| SCTRL_AN SCTRL_AP    | F4         | I                  | LVDS   | DDR          | Differential         | Serial control positive | 9551.5             |               |
| SCTRL_BN             | N4         | l<br>I             | LVDS   | DDR          | Differential         | Serial control negative | 9804.93            |               |
| SCTRL_BP             | M4         | ı                  | LVDS   | DDR          | Differential         | Serial control positive | 9894.56            |               |
| SCTRL_CN             | E23        | ı                  | LVDS   | DDR          | Differential         | Serial control negative | 9192.49            |               |
| SCTRL_CP             | F23        | ı                  | LVDS   | DDR          | Differential         | Serial control positive | 9292.66            |               |
| SCTRL_DN             | M23        | ı                  | LVDS   | DDR          | Differential         | Serial control negative | 9193.21            |               |
| SCTRL_DP             | L23        | ı                  | LVDS   | DDR          | Differential         | Serial control positive | 9286.68            |               |
| DCLK_AN              | C5         | ı                  | LVDS   |              | Differential         | Clock negative          | 9486.8             |               |
| DCLK_AP              | C4         | ı                  | LVDS   |              | Differential         | Clock positive          | 9587.94            |               |
| DCLK_BN              | P5         | ı                  | LVDS   |              | Differential         | Clock negative          | 9678.16            |               |
| DCLK_BP              | P4         | ı                  | LVDS   |              | Differential         | Clock positive          | 9786.01            |               |
| DCLK_CN              | E21        | ı                  | LVDS   |              | Differential         | Clock negative          | 9542.68            |               |
| DCLK_CP              | E22        | ı                  | LVDS   |              | Differential         | Clock positive          | 9642.8             |               |
|                      |            | 1                  |        | 1            |                      | Control of              |                    |               |



| PIN                                |  |                    |          | DATA         | INTERNAL                |   | TRACE           |
|------------------------------------|--|--------------------|----------|--------------|-------------------------|---|-----------------|
| NAME                               | NO.  | I/O <sup>(2)</sup> | SIGNAL   | DATA<br>RATE | INTERNAL<br>TERMINATION | DESCRIPTION   | LENGTH<br>(mil) |
| DCLK_DN                            | M21  | ı                  | LVDS     |              | Differential            | Clock negative  | 9542.68         |
| DCLK_DP                            | M22  | I                  | LVDS     |              | Differential            | Clock positive  | 9636.09         |
| SCPCLK                             | В6   | I                  | LVCMOS   |              | Pull down               | Serial communications port clock. Active only when SCPENZ is logic low.   |                 |
| SCPDI                              | A7   | I                  | LVCMOS   | SDR          | Pull down               | Serial communications port data input.<br>Synchronous to SCPCLK rising edge.  |                 |
| SCPENZ                             | A8   | I                  | LVCMOS   |              | Pull down               | Serial communications port enable active low.   |                 |
| SCPDO                              | B7   | 0                  | LVCMOS   | SDR          |                         | Serial communications port output.  |                 |
| RESET_ADDR(0)                      | T8   |                    |          |              |                         |   |                 |
| RESET_ADDR(1)                      | R9   |                    | 11/01/00 |              | Delle de con            | Baset difference dalaman and and  |                 |
| RESET_ADDR(2)                      | T7   | ı                  | LVCMOS   |              | Pull down               | Reset driver address select   |                 |
| RESET_ADDR(3)                      | R8   |                    |          |              |                         |   |                 |
| RESET_MODE(0)                      | T5   | ı                  | LVCMOS   |              | Pull down               | Reset driver mode select  |                 |
| RESET_SEL(0)                       | T4   | I                  | LVCMOS   |              | Pull down               | Reset driver level select   |                 |
| RESET_SEL(1)                       | L2   | I                  | LVCMOS   |              | Pull down               | Reset driver level select   |                 |
| RESET_STROBE                       | L4   | I                  | LVCMOS   |              | Pull down               | Rising edge latches in RESET_ADDR, RESET_MODE, & RESET_SEL  |                 |
| PWRDNZ                             | A4   | I                  | LVCMOS   |              | Pull down               | Active low device reset   |                 |
| RESET_OEZ                          | T14  | I                  | LVCMOS   |              | Pull up                 | Active low output enable for internal reset driver circuits   |                 |
| RESET_IRQZ                         | R14  | 0                  | LVCMOS   |              |                         | Active low output interrupt to DLP display controller   |                 |
| EN_OFFSET                          | C3   | 0                  | LVCMOS   |              |                         | Active high enable for external V <sub>OFFSET</sub> regulator   |                 |
| PG_OFFSET                          | A2   | I                  | LVCMOS   |              | Pull up                 | Active low fault from external V <sub>OFFSET</sub> regulator  |                 |
| NO CONNECT                         | A16, B14,<br>E10, E11,<br>E12, E13,<br>E14, E15,<br>E16, E17,<br>M12, M13,<br>M14, M15,<br>K2, G2,<br>L24, F24,<br>M16, M17,<br>M18, E18 | NC                 |          |              |                         | Do not connect on DLP system board.   |                 |
| SCP_TEST_MUX                       | A5   | I                  | LVCMOS   |              | Pull down               | Connect to ground on DLP system board   |                 |
| V <sub>BIAS</sub> <sup>(3)</sup>   | A19, A20,<br>T19, T20  | Р                  | Analog   |              |                         | Supply voltage for positive bias level of micromirror reset signal.   |                 |
| V <sub>RESET</sub> <sup>(3)</sup>  | A10, A11,<br>T10, T11  | Р                  | Analog   |              |                         | Supply voltage for negative reset level of micromirror reset signal   |                 |
| V <sub>OFFSET</sub> <sup>(3)</sup> | A1, C25,<br>P25, T1,<br>T13  | Р                  | Analog   |              |                         | Supply voltage for HVCMOS logic. Supply voltage for positive offset level of micromirror reset signal. Supply voltage for stepped high voltage at micromirror address electrodes. |                 |

<sup>(3)</sup>  $V_{BIAS}$ ,  $V_{CC}$ ,  $V_{OFFSET}$ , and  $V_{RESET}$  power supplies must be connected for proper DMD operation.



| PIN                            |   | 1(0(2)             | OLONAL DATA INTERNAL DECOR |      | 2-22-1-1    | TRACE   |                 |
|--------------------------------|---|--------------------|----------------------------|------|-------------|---|-----------------|
| NAME                           | NO.   | I/O <sup>(2)</sup> | SIGNAL                     | RATE | TERMINATION | DESCRIPTION   | LENGTH<br>(mil) |
| Vcc <sup>(3)</sup>             | A13, A14,<br>D1, E1,<br>F21, F22,<br>G3, G4,<br>G21, G22,<br>G23, H3,<br>H4, H21,<br>H22, H23,<br>J3, J4,<br>J21, J22,<br>J23, K3,<br>K4, K21,<br>K22, K23,<br>L21, L22,<br>M1, M2  | Р                  | Analog                     |      |             | Supply voltage for LVCMOS core. Supply voltage for positive offset level of micromirror reset signal during Power down. Supply voltage for normal high level at micromirror address electrodes. |                 |
| V <sub>SS</sub> <sup>(4)</sup> | A3, A6,<br>A9, A12,<br>A15, A17,<br>A18,A21,<br>A22, B15,<br>B24, C2,<br>D5, D8,<br>D11, D14,<br>D17, D20,<br>D23, E3,<br>E24, L3,<br>M24, N5,<br>N8, N11,<br>N14, N17,<br>N20, N23,<br>P2, R15,<br>R24, T3,<br>T6, T9,<br>T12, T15,<br>T16, T17,<br>T18, T21,<br>T22 | G                  |                            |      |             | Device ground. Common return for all power.   |                 |

<sup>(4)</sup>  $V_{SS}$  must be connected for proper DMD operation.



## 6 Specifications

#### 6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|   |  | MIN  | MAX            | UNIT |
|---|--|------|----------------|------|
| SUPPLY VOLTAGI                          | ES   |      |                |      |
| V <sub>CC</sub>                         | Supply voltage for LVCMOS core logic <sup>(2)</sup>  | -0.5 | 2.3            | V    |
| V <sub>OFFSET</sub>                     | Supply voltage for HVCMOS and micromirror electrode (2)(3)   | -0.5 | 11             | V    |
| V <sub>BIAS</sub>                       | Supply voltage for micromirror electrode (2)   | -0.5 | 19             | V    |
| V <sub>RESET</sub>                      | Supply voltage for micromirror electrode (2)   | -15  | -0.3           | V    |
| V <sub>BIAS</sub> - V <sub>OFFSET</sub> | Supply voltage difference (absolute value) <sup>(4)</sup>  |      | 11             | V    |
| V <sub>BIAS</sub> - V <sub>RESET</sub>  | Supply voltage difference (absolute value) <sup>(5)</sup>  |      | 34             | V    |
| INPUT VOLTAGES                          |  |      |                |      |
|   | Input voltage for all other LVCMOS input pins <sup>(2)</sup>                                       | -0.5 | $V_{CC} + 0.5$ | V    |
| V <sub>ID</sub>                         | Input differential voltage (absolute value) (6)  |      | 500            | mV   |
| I <sub>ID</sub>                         | Input differential current <sup>(7)</sup>  |      | 6.3            | mA   |
| CLOCKS                                  |  |      |                |      |
| $f_{CLOCK}$                             | Clock frequency for LVDS interface, DCLK_A   |      | 400            | MHz  |
| $f_{CLOCK}$                             | Clock frequency for LVDS interface, DCLK_B   |      | 400            | MHz  |
| $f_{CLOCK}$                             | Clock frequency for LVDS interface, DCLK_C   |      | 400            | MHz  |
| $f_{CLOCK}$                             | Clock frequency for LVDS interface, DCLK_D   |      | 400            | MHz  |
| ENVIRONMENTAL                           |  |      |                |      |
| T <sub>ARRAY</sub> and                  | Temperature, operating <sup>(8)</sup>  | -20  | 90             | °C   |
| T <sub>WINDOW</sub>                     | Temperature, non-operating <sup>(8)</sup>  | -40  | 90             | °C   |
| T <sub>DELTA</sub>                      | Absolute temperature delta between any point on the window edge and the ceramic test point TP1 (9) |      | 30             | °C   |
| T <sub>DP</sub>                         | Dew point temperature, operating and non-operating (noncondensing)                                 |      | 81             | °C   |

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device is not implied at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure above or below the Recommended Operating Conditions for extended periods of time may affect device reliability.
- (2) All voltages are referenced to the common ground V<sub>SS</sub>. Correct DMD operation requires V<sub>BIAS</sub>, V<sub>CC</sub>, V<sub>OFFSET</sub>, and V<sub>RESET</sub> power supplies . V<sub>SS</sub> must also be connected.
- (3) V<sub>OFFSET</sub> supply transients must be within specified voltages.
- (4) Exceeding the recommended allowable voltage difference between V<sub>BIAS</sub> and V<sub>OFFSET</sub> may result in excessive current draw.
- (5) Exceeding the recommended allowable voltage difference between V<sub>BIAS</sub> and V<sub>RESET</sub> may result in excessive current draw.
- (6) This maximum LVDS input voltage rating applies when each input of a differential pair is at the same voltage potential.
- (7) LVDS differential inputs must not exceed the specified limit or damage may result to the internal termination resistors.
- (8) The highest temperature of the active array (as calculated using Micromirror Array Temperature Calculation) or of any point along the window edge is defined in Figure 10. The highest window edge temperature is measured using the locations of thermal test points TP2, TP3, TP4, and TP5 in Figure 10. If a particular application causes another point on the window edge to be at a higher temperature, use that point.
- (9) Temperature delta is the largest difference between the ceramic test point 1 (TP1) and anywhere on the window edge as shown in Figure 10. The window test points TP2, TP3, TP4, and TP5 shown in Figure 10 typically result in the worst case delta. If a particular application causes another point on the window edge to result in a larger delta temperature, that point should be used.

#### 6.2 Storage Conditions

Applicable to the DMD as a component or non-operating in a system

| - In the control of t | are are a comparison or many approximately an are a comparison of the compariso |     |     |      |
|--|---|-----|-----|------|
|  |   | MIN | MAX | UNIT |
| T <sub>DMD</sub>   | DMD storage temperature   | -40 | 85  | °C   |
| T <sub>DP-AVG</sub>  | Average dew point temperature, non-condensing (1)   |     | 24  | °C   |
| T <sub>DP-ELR</sub>  | Elevated dew point temperature range, non-condensing (2)  | 28  | 36  | °C   |

(1) The average temperature over time (including storage and operating temperatures) that the device is not in the elevated dew point temperature range.

(2) Exposure to dew point temperatures in the elevated range during storage and operation should be limited to less than a total cumulative time of CT<sub>ELR</sub>.



## **Storage Conditions (continued)**

Applicable to the DMD as a component or non-operating in a system

|                   |   | MIN MAX | UNIT   |
|-------------------|---|---------|--------|
| CT <sub>ELR</sub> | Cumulative time in elevated dew point temperature range | 6       | months |

#### 6.3 ESD Ratings

|                    |               |   | VALUE | UNIT |
|--------------------|---------------|---|-------|------|
| .,                 | Electrostatic | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>   | ±2000 | .,   |
| V <sub>(ESD)</sub> | discharge     | Charged device model (CDM), per JEDEC specification JESD22-C101 (2) | ±500  | V    |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 6.4 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted). The functional performance of the device specified in this data sheet is achieved when operating the device within the limits defined by this table. No level of performance is implied when operating the device above or below these limits.

|  |   | MIN                   | NOM | MAX                   | UNIT |
|--|---|-----------------------|-----|-----------------------|------|
| VOLTAGE SUPP                               | PLY   |                       |     |                       |      |
| V <sub>CC</sub>                            | LVCMOS logic supply voltage <sup>(1)</sup>  | 1.65                  | 1.8 | 1.95                  | V    |
| V <sub>OFFSET</sub>                        | Mirror electrode and HVCMOS voltage <sup>(1)(2)</sup>                                   | 9.5                   | 10  | 10.5                  | V    |
| V <sub>BIAS</sub>                          | Mirror electrode voltage <sup>(1)</sup>   | 17.5                  | 18  | 18.5                  | V    |
| V <sub>RESET</sub>                         | Mirror electrode voltage <sup>(1)</sup>   | -14.5                 | -14 | -13.5                 | V    |
| V <sub>BIAS</sub> –<br>V <sub>OFFSET</sub> | Supply voltage difference (absolute value) <sup>(3)</sup>                               |                       |     | 10.5                  | V    |
| V <sub>BIAS</sub> – V <sub>RESET</sub>     | Supply voltage difference (absolute value) (4)  |                       |     | 33                    | V    |
| LVCMOS INTER                               | FACE  |                       |     |                       |      |
| V <sub>IH(DC)</sub>                        | DC input high voltage (5)   | 0.7 × V <sub>CC</sub> |     | V <sub>CC</sub> + 0.3 | V    |
| V <sub>IL(DC)</sub>                        | DC input low voltage <sup>(5)</sup>   | -0.3                  |     | $0.3 \times V_{CC}$   | V    |
| V <sub>IH(AC)</sub>                        | AC input high voltage (5)   | 0.8 × V <sub>CC</sub> |     | $V_{CC} + 0.3$        | V    |
| V <sub>IL(AC)</sub>                        | AC input low voltage <sup>(5)</sup>   | -0.3                  |     | 0.2 × V <sub>CC</sub> | V    |
| t <sub>PWRDNZ</sub>                        | PWRDNZ pulse duration <sup>(6)</sup>  | 10                    |     |                       | ns   |
| SCP INTERFAC                               | E   |                       |     |                       |      |
| $f_{\sf SCPCLK}$                           | SCP clock frequency <sup>(7)</sup>  |                       |     | 500                   | kHz  |
| t <sub>SCP_PD</sub>                        | Propagation delay, clock to Q, from rising–edge of SCPCLK to valid SCPDO <sup>(8)</sup> | 0                     |     | 900                   | ns   |
| t <sub>SCP_NEG_ENZ</sub>                   | Time between falling-edge of SCPENZ and the first rising-edge of SCPCLK                 | 1                     |     |                       | μs   |
| t <sub>SCP_POS_ENZ</sub>                   | Time between falling-edge of SCPCLK and the rising-edge of SCPENZ                       | 1                     |     |                       | μs   |
| t <sub>SCP_DS</sub>                        | SCPDI clock setup time (before SCPCLK falling edge) (8)                                 | 800                   |     |                       | ns   |
| t <sub>SCP DH</sub>                        | SCPDI hold time (after SCPCLK falling edge) (8)   | 900                   |     |                       | ns   |

- All voltages reference common ground V<sub>SS</sub>. Correct DMD operation requires V<sub>BIAS</sub>, V<sub>CC</sub>, V<sub>OFFSET</sub>, and V<sub>RESET</sub> power supplies. V<sub>SS</sub> must also be connected.
- (2) V<sub>OFFSET</sub> supply transient values must be below the specified maximum voltage.
- (3) To prevent excess current, the supply voltage difference |V<sub>BIAS</sub> V<sub>OFFSET</sub>| must be less than specified limit. See *Power Supply Recommendations*, Figure 14, and Table 8.
- (4) To prevent excess current, the supply voltage difference |V<sub>BIAS</sub> V<sub>RESET</sub>| must be less than specified limit. See *Power Supply Recommendations*, Figure 14, and Table 8.
- (5) Low-speed interface is LPSDR and adheres to the Electrical Characteristics and AC/DC Operating Conditions table in JEDEC Standard No. 209B, "Low-Power Double Data Rate (LPDDR)" JESD209B. Tester conditions for V<sub>IH</sub> and V<sub>IL</sub>.
   (a) Frequency = 60 MHz. Maximum rise time = 2.5 ns @ (20% 80%)
  - (b) Frequency = 60 MHz. Maximum fall time = 2.5 ns @ (80% 20%)
- 6) PWRDNZ input pin resets the SCP and disables the LVDS receivers. PWRDNZ input pin overrides SCPENZ input pin and tristates the SCPDO output pin.
- (7) The SCP clock is a gated clock. Duty cycle must be 50% ± 10%. SCP parameter is related to the frequency of DCLK.
- (8) See Figure 2.

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## **Recommended Operating Conditions (continued)**

Over operating free-air temperature range (unless otherwise noted). The functional performance of the device specified in this data sheet is achieved when operating the device within the limits defined by this table. No level of performance is implied when operating the device above or below these limits.

|                         |   | MIN | NOM | MAX | UNIT |
|-------------------------|---|-----|-----|-----|------|
| t <sub>SCP_PW_ENZ</sub> | SCPENZ inactive pulse duration (high level) | 2   |     |     | μs   |



#### **Recommended Operating Conditions (continued)**

Over operating free-air temperature range (unless otherwise noted). The functional performance of the device specified in this data sheet is achieved when operating the device within the limits defined by this table. No level of performance is implied when operating the device above or below these limits.

|                        | ng the device above or below these limits.  | MIN  | NOM        | MAX                      | UNIT               |
|------------------------|---|------|------------|--------------------------|--------------------|
| LVDS INTERF            | FACE  |      |            |                          |                    |
| $f_{CLOCK}$            | Clock frequency for LVDS interface (all channels), DCLK <sup>(9)</sup>                              |      |            | 400                      | MHz                |
| V <sub>ID</sub>        | Input differential voltage (absolute value) (10)  | 150  | 300        | 440                      | mV                 |
| V <sub>CM</sub>        | Common mode voltage <sup>(10)</sup>   | 1100 | 1200       | 1300                     | mV                 |
| V <sub>LVDS</sub>      | LVDS voltage <sup>(10)</sup>  | 880  |            | 1520                     | mV                 |
| t <sub>LVDS_RSTZ</sub> | Time required for LVDS receivers to recover from PWRDNZ   |      |            | 2000                     | ns                 |
| Z <sub>IN</sub>        | Internal differential termination resistance  | 80   | 100        | 120                      | Ω                  |
| Z <sub>LINE</sub>      | Line differential impedance (PWB/trace)   | 90   | 100        | 110                      | Ω                  |
| ENVIRONMEN             | NTAL  |      |            |                          |                    |
|                        | Array temperature, long-term operational (11)(12)(13)(14)   | 0    |            | 40 to 70 <sup>(13)</sup> | °C                 |
| _                      | Array temperature, short–term operational, 25 hr max <sup>(12)(15)</sup>                            | -20  |            | -10                      | °C                 |
| T <sub>ARRAY</sub>     | Array temperature, short–term operational, 500 hr max <sup>(12)(15)</sup>                           | -10  |            | 0                        | °C                 |
|                        | Array temperature, short–term operational, 500 hr max <sup>(12)(15)</sup>                           | 70   |            | 75                       | °C                 |
| T <sub>WINDOW</sub>    | Window temperature – operational (16)(17)   |      |            | 85                       | °C                 |
| T <sub>DELTA</sub>     | Absolute temperature delta between any point on the window edge and the ceramic test point TP1 (18) |      |            | 14                       | °C                 |
| T <sub>DP -AVG</sub>   | Average dew point temperature (non–condensing) <sup>(19)</sup>                                      |      |            | 24                       | °C                 |
| T <sub>DP-ELR</sub>    | Elevated dew point temperature range (non-condensing) (20)  | 28   |            | 36                       | °C                 |
| CT <sub>ELR</sub>      | Cumulative time in elevated dew point temperature range   |      |            | 6                        | months             |
| ILL <sub>UV</sub>      | Illumination wavelengths < 400 nm <sup>(11)</sup>   |      | 0.68       | 2.00                     | mW/cm <sup>2</sup> |
| ILL <sub>VIS</sub>     | Illumination wavelengths between 400 nm and 700 nm  | The  | rmally lim | ited                     | mW/cm <sup>2</sup> |
| ILL <sub>IR</sub>      | Illumination wavelengths > 700 nm   |      |            | 10                       | mW/cm <sup>2</sup> |
| $ILL_{\theta}$         | Illumination marginal ray angle (17)  |      |            | 55                       | degrees            |

- (9) See LVDS timing requirements in *Timing Requirements* and Figure 6.
- (10) See Figure 5 LVDS waveform requirements.
- (11) Simultaneous exposure of the DMD to the maximum *Recommended Operating Conditions* for temperature and UV illumination reduces device lifetime.
- (12) The array temperature cannot be measured directly and must be computed analytically from the temperature measured at test point 1 (TP1) shown in Figure 10 and the package thermal resistance using the *Micromirror Array Temperature Calculation*.
- (13) Per Figure 1, the maximum operational array temperature should be derated based on the micromirror landed duty cycle that the DMD experiences in the end application. See *Micromirror Landed-On/Landed-Off Duty Cycle* for a definition of micromirror landed duty cycle.
- (14) Long-term is defined as the useful life of the device.
- (15) Short-term is the total cumulative time over the useful life of the device.
- (16) The locations of thermal test points TP2, TP3, TP4, and TP5 shown in Figure 10 are intended to measure the highest window edge temperature. For most applications, the locations shown are representative of the highest window edge temperature. If a particular application causes additional points on the window edge to be at a higher temperature, test points should be added to those locations.
- (17) The maximum marginal ray angle of the incoming illumination light at any point in the micromirror array, including pond of micromirrors (POM), should not exceed 55 degrees from the normal to the device array plane. The device window aperture has not necessarily been designed to allow incoming light at higher maximum angles to pass to the micromirrors, and the device performance has not been tested nor qualified at angles exceeding this. Illumination light exceeding this angle outside the micromirror array (including POM) will contribute to thermal limitations described in this document, and may negatively affect lifetime.
- (18) Temperature delta is the highest difference between the ceramic test point 1 (TP1) and anywhere on the window edge as shown in Figure 10. The window test points TP2, TP3, TP4, and TP5 shown in Figure 10 are intended to result in the worst case delta temperature. If a particular application causes another point on the window edge to result in a larger delta in temperature, that point should be used.
- (19) The average over time (including storage and operating) that the device is not in the 'elevated dew point temperature range'.
- (20) Exposure to dew point temperatures in the elevated range during storage and operation should be limited to less than a total cumulative time of CT<sub>ELR</sub>.



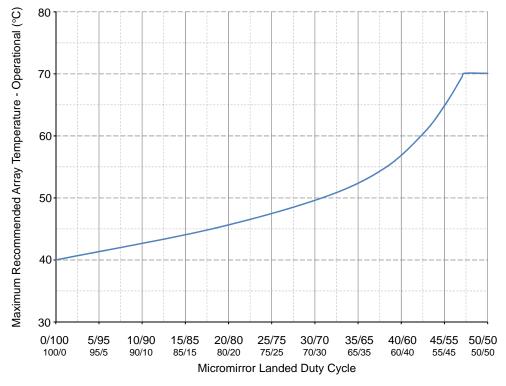


Figure 1. Maximum Recommended Array Temperature - Derating Curve

#### 6.5 Thermal Information

|  | DLP470TP    |      |
|--|-------------|------|
| THERMAL METRIC   | FQN Package | UNIT |
|  | 250 PINS    |      |
| Thermal resistance, active area to test point 1 (TP1) <sup>(1)</sup> | 1.2         | °C/W |

(1) The DMD is designed to conduct absorbed and dissipated heat to the back of the package. The cooling system must be capable of maintaining the package within the temperature range specified in the *Recommended Operating Conditions*. The total heat load on the DMD is largely driven by the incident light absorbed by the active area; although other contributions include light energy absorbed by the window aperture and electrical power dissipation of the array. Optical systems should be designed to minimize the light energy falling outside the window clear aperture since any additional thermal load in this area can significantly degrade the reliability of the device.



#### 6.6 Electrical Characteristics

Over operating free-air temperature range (unless otherwise noted)

|                     | PARAMETER   | TEST CONDITIONS                                  | MIN                   | TYP MAX             | UNIT |
|---------------------|---|--|-----------------------|---------------------|------|
| V <sub>OH</sub>     | High level output voltage                         | $V_{CC} = 1.8 \text{ V}, I_{OH} = -2 \text{ mA}$ | 0.8 × V <sub>CC</sub> |                     | V    |
| V <sub>OL</sub>     | Low level output voltage                          | $V_{CC} = 1.95 \text{ V}, I_{OL} = 2 \text{ mA}$ |                       | $0.2 \times V_{CC}$ | V    |
| l <sub>oz</sub>     | High impedance output current                     | V <sub>CC</sub> = 1.95 V                         | -40                   | 25                  | μA   |
| I <sub>IL</sub>     | Low level input current                           | $V_{CC} = 1.95 \text{ V}, V_{I} = 0$             | -1                    |                     | μA   |
| I <sub>IH</sub>     | High level input current (1)(2)                   | $V_{CC} = 1.95 \text{ V}, V_{I} = V_{CC}$        |                       | 110                 | μA   |
| I <sub>CC</sub>     | Supply current V <sub>CC</sub>                    | V <sub>CC</sub> = 1.95 V                         |                       | 1290                | mA   |
| I <sub>OFFSET</sub> | Supply current V <sub>OFFSET</sub> (2)            | V <sub>OFFSET</sub> = 10.5 V                     |                       | 13.2                | mA   |
| I <sub>BIAS</sub>   | Supply current V <sub>BIAS</sub> (2) (3)          | V <sub>BIAS</sub> = 18.5 V                       |                       | 3.6                 | mA   |
| I <sub>RESET</sub>  | Supply current V <sub>RESET</sub> (3)             | V <sub>RESET</sub> = −14.5 V                     |                       | -9                  | mA   |
| P <sub>CC</sub>     | Supply power dissipation V <sub>CC</sub>          | V <sub>CC</sub> = 1.95 V                         |                       | 2515.5              | mW   |
| P <sub>OFFSET</sub> | Supply power dissipation V <sub>OFFSET</sub> (2)  | V <sub>OFFSET</sub> = 10.5 V                     |                       | 138.6               | mW   |
| P <sub>BIAS</sub>   | Supply power dissipation V <sub>BIAS</sub> (2)(3) | V <sub>BIAS</sub> = 18.5 V                       |                       | 66.6                | mW   |
| P <sub>RESET</sub>  | Supply power dissipation V <sub>RESET</sub> (3)   | V <sub>RESET</sub> = -14.5 V                     |                       | 130.5               | mW   |
| P <sub>TOTAL</sub>  | Supply power dissipation V <sub>TOTAL</sub>       |  |                       | 2851.2              | mW   |

## 6.7 Capacitance at Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                        | PARAMETER                                   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------|---|-----------------|-----|-----|-----|------|
| C <sub>I_lvds</sub>    | LVDS input capacitance 2x LVDS              | f = 1  MHz      |     |     | 20  | pF   |
| C <sub>I_nonlvds</sub> | Non-LVDS input capacitance 2x LVDS          | f = 1  MHz      |     |     | 20  | pF   |
| C <sub>I_tdiode</sub>  | Temperature diode input capacitance 2x LVDS | f = 1 MHz       |     |     | 30  | pF   |
| Co                     | Output capacitance                          | f = 1  MHz      |     |     | 20  | pF   |

 <sup>(1)</sup> Applies to LVCMOS pins only. Excludes LVDS pins and MBRST (15:0) pins.
 (2) To prevent excess current, the supply voltage difference |V<sub>BIAS</sub> - V<sub>OFFSET</sub>| must be less than the specified limits listed in the

Recommended Operating Conditions table.

To prevent excess current, the supply voltage difference |V<sub>BIAS</sub> - V<sub>RESET</sub>| must be less than the specified limit in Recommended Operating Conditions.

# TEXAS INSTRUMENTS

## 6.8 Timing Requirements

|                    | minig itequiren |   | MIN   | NOM  | MAX  | UNIT |
|--------------------|-----------------|---|-------|------|------|------|
| SCP <sup>(1)</sup> |                 |   |       |      |      |      |
| t <sub>r</sub>     | Rise slew rate  | 20% to 80% reference points                                   | 1     |      | 3    | V/ns |
| t <sub>f</sub>     | Fall slew rate  | 80% to 20% reference points                                   | 1     |      | 3    | V/ns |
| LVDS(2)            |                 |   |       |      |      |      |
| t <sub>r</sub>     | Rise slew rate  | 20% to 80% reference points                                   | 0.7   | 1    |      | V/ns |
| t <sub>f</sub>     | Fall slew rate  | 80% to 20% reference points                                   | 0.7   | 1    |      | V/ns |
|                    |                 | DCLK_A, LVDS pair   | 2.5   |      |      | ns   |
|                    | Olaska svala    | DCLK_B, LVDS pair   | 2.5   |      |      | ns   |
| t <sub>C</sub>     | Clock cycle     | DCLK_C, LVDS pair   | 2.5   |      |      | ns   |
|                    |                 | DCLK_D, LVDS pair   | 2.5   |      |      | ns   |
|                    |                 | DCLK_A LVDS pair  | 1.19  | 1.25 |      | ns   |
|                    | Dalar danatan   | DCLK_B LVDS pair  | 1.19  | 1.25 |      | ns   |
| t <sub>W</sub>     | Pulse duration  | DCLK_C LVDS pair  | 1.19  | 1.25 |      | ns   |
|                    |                 | DCLK_D LVDS pair  | 1.19  | 1.25 |      | ns   |
|                    |                 | D_A(15:0) before DCLK_A, LVDS pair                            | 0.275 |      |      | ns   |
|                    |                 | D_B(15:0) before DCLK_B, LVDS pair                            | 0.275 |      |      | ns   |
|                    |                 | D_C(15:0) before DCLK_C, LVDS pair                            | 0.275 |      |      | ns   |
|                    | O               | D_D(15:0) before DCLK_D, LVDS pair                            | 0.275 |      |      | ns   |
| $t_{Su}$           | Setup time      | SCTRL_A before DCLK_A, LVDS pair                              | 0.275 |      |      | ns   |
|                    |                 | SCTRL_B before DCLK_B, LVDS pair                              | 0.275 |      |      | ns   |
|                    |                 | SCTRL_C before DCLK_C, LVDS pair                              | 0.275 |      |      | ns   |
|                    |                 | SCTRL_D before DCLK_D, LVDS pair                              | 0.275 |      |      | ns   |
|                    |                 | D_A(15:0) after DCLK_A, LVDS pair                             | 0.195 |      |      | ns   |
|                    |                 | D_B(15:0) after DCLK_B, LVDS pair                             | 0.195 |      |      | ns   |
|                    |                 | D_C(15:0) after DCLK_C, LVDS pair                             | 0.195 |      |      | ns   |
|                    | Hald Care       | D_D(15:0) after DCLK_D, LVDS pair                             | 0.195 |      |      | ns   |
| t <sub>h</sub>     | Hold time       | SCTRL_A after DCLK_A, LVDS pair                               | 0.195 |      |      | ns   |
|                    |                 | SCTRL_B after DCLK_B, LVDS pair                               | 0.195 |      |      | ns   |
|                    |                 | SCTRL_C after DCLK_C, LVDS pair                               | 0.195 |      |      | ns   |
|                    |                 | SCTRL_D after DCLK_D, LVDS pair                               | 0.195 |      |      | ns   |
| LVDS(2)            |                 |   |       |      |      |      |
| t <sub>SKEW</sub>  | Skew time       | Channel B relative to channel A <sup>(3)(4)</sup> , LVDS pair | -1.25 |      | 1.25 | ns   |
| t <sub>SKEW</sub>  | Skew time       | Channel D relative to channel C <sup>(5)(6)</sup> , LVDS pair | -1.25 |      | 1.25 | ns   |

- (1) See Figure 3 for rise time and fall time for SCP.
- (2) See Figure 5 for timing requirements for LVDS.
- (3) Channel A (Bus A) includes the following LVDS pairs: DCLK\_AN and DCLK\_AP, SCTRL\_AN and SCTRL\_AP, D\_AN(15:0), and D\_AP(15:0).
- (4) Channel B (Bus B) includes the following LVDS pairs: DCLK\_BN and DCLK\_BP, SCTRL\_BN and SCTRL\_BP, D\_BN(15:0), and D\_BP(15:0).
- (5) Channel C (Bus C) includes the following LVDS pairs: DCLK\_CN and DCLK\_CP, SCTRL\_CN and SCTRL\_CP, D\_CN(15:0), and D\_CP(15:0).
- (6) Channel D (Bus D) includes the following LVDS pairs: DCLK\_DN and DCLK\_DP, SCTRL\_DN and SCTRL\_DP, D\_DN(15:0), and D\_DP(15:0).



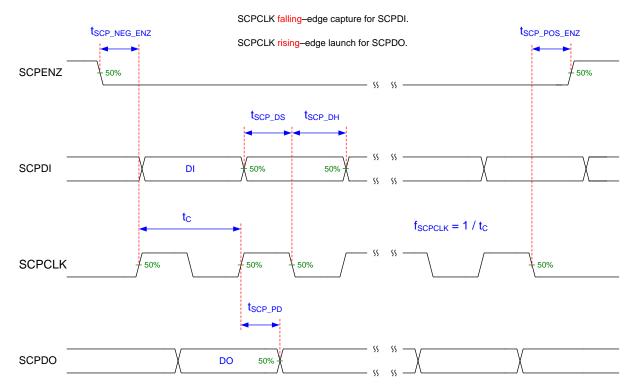


Figure 2. SCP Timing Requirements

See Recommended Operating Conditions for  $f_{\text{SCP\_LK}}$ ,  $t_{\text{SCP\_DH}}$ ,  $t_{\text{SCP\_DH}}$ , and  $t_{\text{SCP\_PD}}$  specifications.

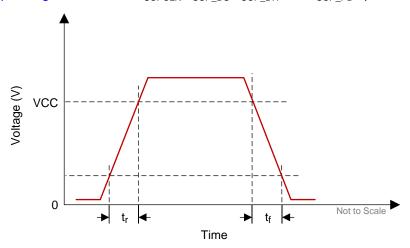


Figure 3. SCP Requirements for Rise and Fall

See *Timing Requirements* for t<sub>r</sub> and t<sub>f</sub> specifications and conditions.



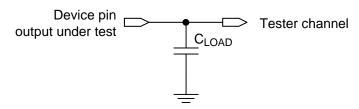


Figure 4. Test Load Circuit for Output Propagation Measurement

The tester pin electronics and its transmission line effects must be taken into account for output timing analysis. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment.

Not to Scale

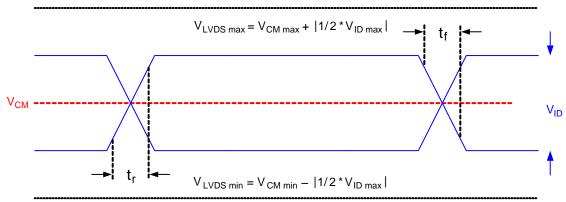


Figure 5. LVDS Waveform Requirements

See Recommended Operating Conditions for  $V_{CM}$ ,  $V_{ID}$ , and  $V_{LVDS}$  specifications and conditions.

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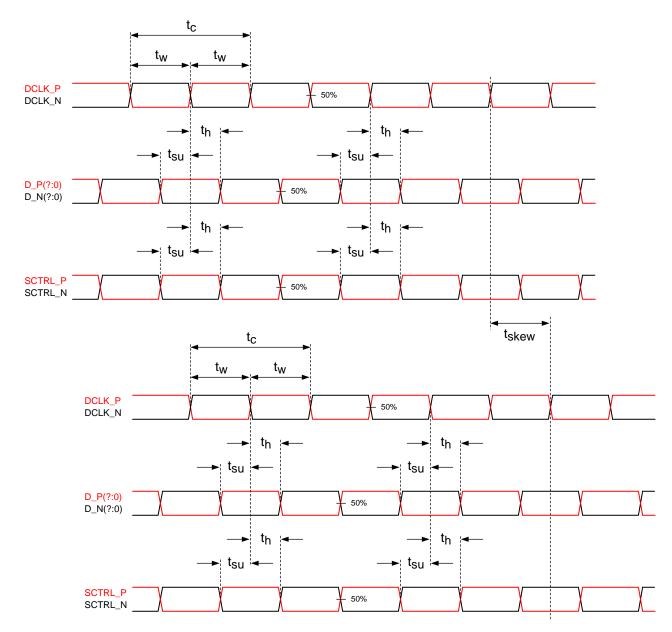


Figure 6. Timing Requirements

See *Timing Requirements* for timing requirements and LVDS pairs per channel (bus) defining  $D_P(?:0)$  and  $D_N(?:0)$ .



## 6.9 System Mounting Interface Loads

**Table 1. System Mounting Interface Loads** 

| PARAMETER                                | MIN | NOM | MAX | UNIT |
|--|-----|-----|-----|------|
| Thermal interface area <sup>(1)</sup>    |     |     | 100 | N    |
| Electrical interface area <sup>(1)</sup> |     |     | 245 | N    |

(1) Uniformly distributed within area shown in Figure 7.

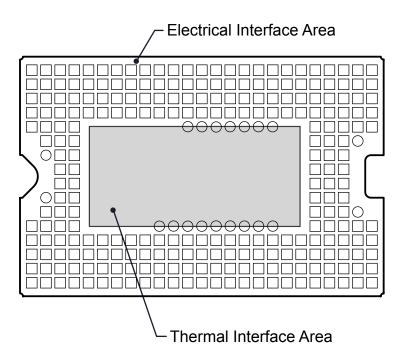


Figure 7. System Mounting Interface Loads



## 6.10 Micromirror Array Physical Characteristics

**Table 2. Micromirror Array Physical Characteristics** 

| • •  |  |   |  |  |  |
|--|--|---|--|--|--|
| PARAMETER DESCRIPTION                        |  |   |  |  |  |
| M  | 1920   | micromirrors  |  |  |  |
| N  | 1080   | micromirrors  |  |  |  |
| Р  | 5.4  | μm  |  |  |  |
| Micromirror pitch x number of active columns | 10.368   | mm  |  |  |  |
| Micromirror pitch x number of active rows    | 5.832  | mm  |  |  |  |
| Pond of micromirrors (POM)                   | 20   | micromirrors/side   |  |  |  |
|  | M N P Micromirror pitch × number of active columns Micromirror pitch × number of active rows | M         1920           N         1080           P         5.4           Micromirror pitch × number of active columns         10.368           Micromirror pitch × number of active rows         5.832 |  |  |  |

- (1) See Figure 8.
- (2) The fast switching speed of the DMD micromirrors combined with advanced DLP image processing algorithms enables each micromirror to display four distinct pixels on the screen during every frame, resulting in a full 3840 × 2160 pixel image being displayed.
- (3) The structure and qualities of the border around the active array includes a band of partially functional micromirrors referred to as the *Pond Of Micromirrors* (POM). These micromirrors are structurally and/or electrically prevented from tilting toward the bright or ON state but still require an electrical bias to tilt toward the OFF state.

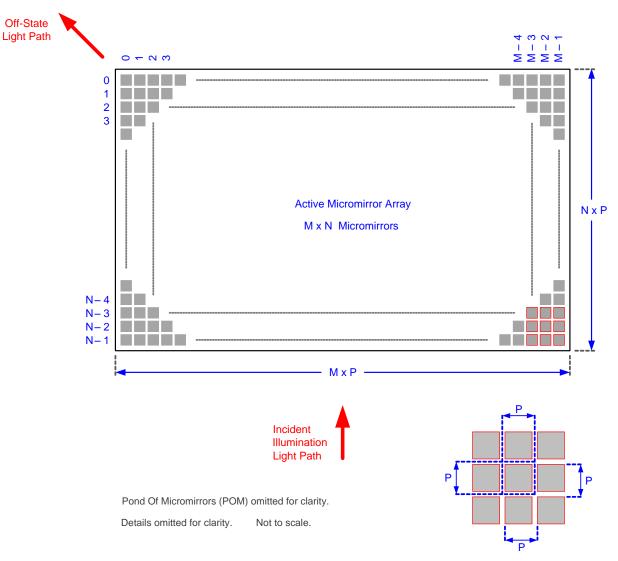


Figure 8. Micromirror Array Physical Characteristics

Refer to section *Micromirror Array Physical Characteristics* table for M, N, and P specifications.



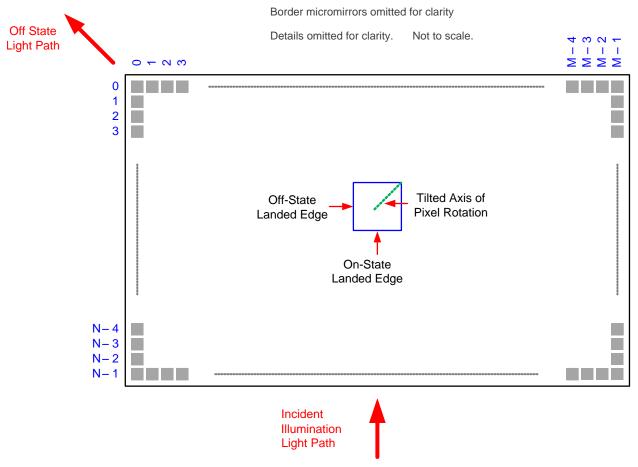
#### 6.11 Micromirror Array Optical Characteristics

#### **Table 3. Micromirror Array Optical Characteristics**

| PARAMETER  |                                 | MIN  | NOM | MAX | UNIT         |  |
|--|---------------------------------|------|-----|-----|--------------|--|
| Micromirror tilt angle                           | DMD landed state <sup>(1)</sup> |      | 17  |     | degrees      |  |
| Micromirror tilt angle tolerance (2)(3)(4)(5)    |                                 | -1.4 |     | 1.4 | degrees      |  |
|  | Landed ON state                 |      | 270 |     | d            |  |
| Micromirror tilt direction (6) (7)               | Landed OFF state                |      | 180 |     | degrees      |  |
| Micromirror crossover time <sup>(8)</sup>        | Typical performance             |      | 1   | 3   | _            |  |
| Micromirror switching time <sup>(9)</sup>        | Typical performance             | 6    |     |     | μS           |  |
| Number of out-of-specification micromirrors (10) | Adjacent micromirrors           |      |     | 0   | mioromirroro |  |
|  | Non-adjacent micromirrors       |      |     | 10  | micromirrors |  |

- (1) Measured relative to the plane formed by the overall micromirror array.
- (2) Additional variation exists between the micromirror array and the package datums.
- (3) Represents the landed tilt angle variation relative to the nominal landed tilt angle.
- (4) Represents the variation that can occur between any two individual micromirrors, located on the same device or located on different devices.
- (5) For some applications, it is critical to account for the micromirror tilt angle variation in the overall system optical design. With some system optical designs, the micromirror tilt angle variation within a device may result in perceivable non-uniformities in the light field reflected from the micromirror array. With some system optical designs, the micromirror tilt angle variation between devices may result in colorimetry variations, system efficiency variations or system contrast variations.
- (6) When the micromirror array is landed (not parked), the tilt direction of each individual micromirror is dictated by the binary contents of the CMOS memory cell associated with each individual micromirror. A binary value of 1 results in a micromirror landing in the ON state direction. A binary value of 0 results in a micromirror landing in the OFF state direction.
- (7) Micromirror tilt direction is measured as in a typical polar coordinate system: Measuring counter-clockwise from a 0° reference which is aligned with the +X Cartesian axis.
- (8) The time required for a micromirror to nominally transition from one landed state to the opposite landed state.
- (9) The minimum time between successive transitions of a micromirror.
- (10) An out-of-specification micromirror is defined as a micromirror that is unable to transition between the two landed states within the specified micromirror switching time.





- (1) Pond of micromirrors (POM) omitted for clarity.
- (2) Refer to Micromirror Array Physical Characteristics table for M, N, and P specifications.

Figure 9. Micromirror Landed Orientation and Tilt



#### 6.12 Window Characteristics

#### **Table 4. DMD Window Characteristics**

| DI  | DESCRIPTION <sup>(1)</sup>   |     |                  |         |  |
|---|--|-----|------------------|---------|--|
| Window material   |  |     | Corning Eagle XG |         |  |
| Window refractive index   | At wavelength 546.1 nm   |     | 1.5119           |         |  |
| Window aperture <sup>(2)</sup>                                    |  |     |                  | See (2) |  |
| Illumination overfill (3)   |  |     |                  | See (3) |  |
| Window transmittance, single-pass through both surfaces and glass | Minimum within the wavelength range 420 nm to 680 nm. Applies to all angles 0° to 30° AOI. (4) | 97% |                  |         |  |
| Window transmittance, single-pass through both surfaces and glass | Average over the wavelength range 420 nm to 680 nm. Applies to all angles 30° to 45° AOI. (4)  | 97% |                  |         |  |

- (1) See Optical Interface and System Image Quality Considerations for more information.
- (2) See the package mechanical characteristics for details regarding the size and location of the window aperture.
- (3) The active area of the DLP470TP device is surrounded by an aperture on the inside of the DMD window surface that masks structures of the DMD device assembly from normal view. The aperture is sized to anticipate several optical conditions. Overfill light illuminating the area outside the active array can scatter and create adverse effects to the performance of an end application using the DMD. The illumination optical system should be designed to limit light flux incident outside the active array to less than 10% of the average flux level in the active area. Depending on the particular system's optical architecture and assembly tolerances, the amount of overfill light on the outside of the active array may cause system performance degradation.
- (4) Angle of incidence (AOI) is the angle between an incident ray and the normal to a reflecting or refracting surface.

#### 6.13 Chipset Component Usage Specification

Reliable function and operation of the DLP470TP DMD requires that it be used in conjunction with the other components of the applicable DLP chipset, including those components that contain or implement TI DMD control technology. TI DMD control technology consists of the TI technology and devices used for operating or controlling a DLP DMD.

#### **NOTE**

TI assumes no responsibility for image quality artifacts or DMD failures caused by optical system operating conditions exceeding limits described previously.



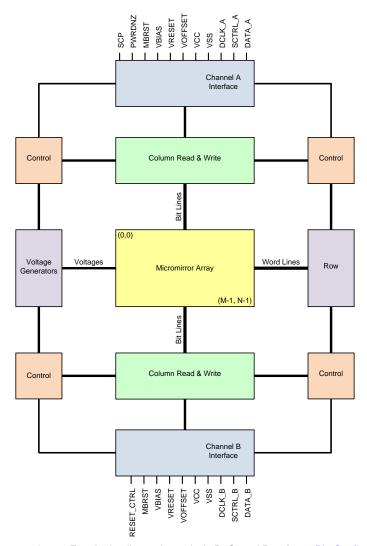
## 7 Detailed Description

#### 7.1 Overview

The DMD is a 0.47-inch diagonal spatial light modulator which consists of an array of highly reflective aluminum micromirrors. The DMD is an electrical input, optical output micro-optical-electrical-mechanical system (MOEMS). The fast switching speed of the DMD micromirrors combined with advanced DLP image processing algorithms enables each micromirror to display four distinct pixels on the screen during every frame, resulting in a full 3840 x 2160 pixel image being displayed. The electrical interface is low voltage differential signaling (LVDS). The DMD consists of a two-dimensional array of 1-bit CMOS memory cells. The array is organized in a grid of M memory cell columns by N memory cell rows. Refer to the *Functional Block Diagram*. The positive or negative deflection angle of the micromirrors can be individually controlled by changing the address voltage of underlying CMOS addressing circuitry and micromirror reset signals (MBRST).

The DLP 0.47" 4K UHD chipset is comprised of the DLP470TP DMD, two DLPC6421 display controllers, the DLPA3005 PMIC, and the LED driver. To ensure reliable operation, the DLP470TP DMD must always be used with the DLP display controller and the PMIC specified in the chipset.

#### 7.2 Functional Block Diagram



Channels C and D are not shown. For pin details on channels A, B, C, and D, refer to *Pin Configuration and Functions* and LVDS interface section of *Timing Requirements*.



#### 7.3 Feature Description

#### 7.3.1 Power Interface

The DMD requires 4 DC voltages: 1.8 V source,  $V_{OFFSET}$ ,  $V_{RESET}$ , and  $V_{BIAS}$ . In a typical LED-based system, 1.8 V is provided by a TPS54320 and the  $V_{OFFSET}$ ,  $V_{RESET}$ , and  $V_{BIAS}$  is managed by the DLPA3005 PMIC and LED driver.

#### **7.3.2 Timing**

The data sheet provides timing at the device pin. For output timing analysis, the tester pin electronics and its transmission line effects must be taken into account. Figure 4 shows an equivalent test load circuit for the output under test. Timing reference loads are not intended to be precise representations of any particular system environment or depiction of the actual load presented by a production test. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. The load capacitance value stated is only for characterization and measurement of AC timing signals. This load capacitance value does not indicate the maximum load the device is capable of driving.

#### 7.4 Device Functional Modes

DMD functional modes are controlled by the DLPC6421 display controller. See the DLPC6421 display controller data sheet or contact a TI applications engineer.

#### 7.5 Optical Interface and System Image Quality Considerations

TI assumes no responsibility for end-equipment optical performance. Achieving the desired end-equipment optical performance involves making trade-offs between numerous component and system design parameters. Optimizing system optical performance and image quality strongly relate to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance is contingent on compliance to the optical system operating conditions described in the following sections.

#### 7.5.1 Numerical Aperture and Stray Light Control

The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device micromirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block out flat-state and stray light from the projection lens. The micromirror tilt angle defines DMD capability to separate the "ON" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the micromirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle (and vice versa), contrast degradation and objectionable artifacts in the display border and/or active area could occur.

#### 7.5.2 Pupil Match

TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within 2° of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the display border and/or active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.

#### 7.5.3 Illumination Overfill

The active area of the device is surrounded by an aperture on the inside DMD window surface that masks structures of the DMD chip assembly from normal view, and is sized to anticipate several optical operating conditions. Overfill light illuminating the window aperture can create artifacts from the edge of the window aperture opening and other surface anomalies that may be visible on the screen. The illumination optical system should be designed to limit light flux incident anywhere on the window aperture from exceeding approximately 10% of the average flux level in the active area. Depending on the particular system optical architecture, overfill light may have to be further reduced below the suggested 10% level in order to be acceptable.



## 7.6 Micromirror Array Temperature Calculation

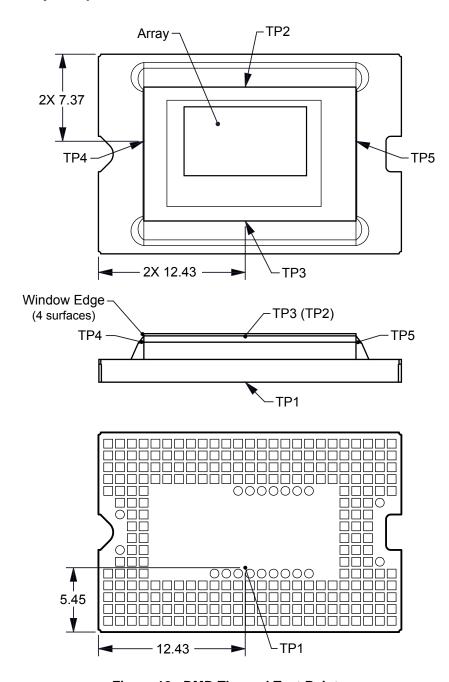


Figure 10. DMD Thermal Test Points



## **Micromirror Array Temperature Calculation (continued)**

Micromirror array temperature cannot be measured directly, therefore it must be computed analytically from measurement points on the outside of the package, the package thermal resistance, the electrical power, and the illumination heat load. The relationship between array temperature and the reference ceramic temperature (thermal test TP1 in Figure 10) is provided by the following equations:

$$\begin{split} T_{ARRAY} &= T_{CERAMIC} + \left(Q_{ARRAY} \times R_{ARRAY-TO-CERAMIC}\right) \\ Q_{ARRAY} &= Q_{ELECTRICAL} + Q_{ILLUMINATION} \end{split}$$

#### where

- T<sub>ARRAY</sub> = Computed array temperature (°C)
- T<sub>CERAMIC</sub> = Measured ceramic temperature (°C) (TP1 location)
- R<sub>ARRAY-TO-CERAMIC</sub> = Thermal resistance of package specified in *Thermal Information* from array to ceramic TP1 (°C/Watt)
- Q<sub>ARRAY</sub> = Total (electrical + absorbed) DMD power on the array (Watts)
- Q<sub>ELECTRICAL</sub> = Nominal electrical power
- $Q_{ILLUMINATION} = (C_{L2W} \times SL)$
- C<sub>L2W</sub> = Conversion constant for screen lumens to power on DMD (Watts/Lumen)
- SL = Measured screen Lumens

The electrical power dissipation of the DMD is variable and depends on the voltages, data rates, and operating frequencies. A nominal electrical power dissipation to use when calculating array temperature is 1.3 W. The absorbed power from the illumination source is variable and depends on the operating state of the micromirrors and the intensity of the light source. The equations shown above are valid for a 1-chip DMD system with projection efficiency from the DMD to the screen of 87%.

The conversion constant  $C_{L2W}$  is calculated to be 0.00266 W/lm based on array characteristics. It assumes a spectral efficiency of 300 lumens/Watt for the projected light and illumination distribution of 83.7% on the active array, and 16.3% on the array border.

The sample calculation for a typical projection application is as follows:

SL = 1500 lm (measured)  $T_{CERAMIC} = 55.0$ °C (measured)

 $C_{L2W} = 0.00266 \text{ W/Im}$  $Q_{ELECTRICAL} = 1.3 \text{ W}$ 

 $Q_{ARRAY} = 1.3 \text{ W} + (0.00266 \text{ W/lm} \times 1500 \text{ lm}) = 5.29 \text{ W}$ 

 $T_{ARRAY} = 55.0$ °C +  $(5.29 \text{ W} \times 1.2$ °C/W) = 61.35°C

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#### 7.7 Micromirror Landed-On/Landed-Off Duty Cycle

#### 7.7.1 Definition of Micromirror Landed-On/Landed-Off Duty Cycle

The micromirror landed-on/landed-off duty cycle (landed duty cycle) denotes the percentage of time that an individual micromirror is landed in the ON state versus the amount of time the same micromirror is landed in the OFF state.

For example, a landed duty cycle of 100/0 indicates that the referenced pixel is in the ON state 100% of the time (and in the OFF state 0% of the time); whereas 0/100 would indicate that the pixel is in the OFF state 100% of the time. Likewise, 50/50 indicates that the pixel is ON for 50% of the time (and OFF for 50% of the time).

Note that when assessing landed duty cycle, the time spent switching from one state (ON or OFF) to the other state (OFF or ON) is considered negligible and is thus ignored.

Since a micromirror can only be landed in one state or the other (ON or OFF), the two numbers (percentages) always add to 100.

#### 7.7.2 Landed Duty Cycle and Useful Life of the DMD

Knowing the long-term average landed duty cycle (of the end product or application) is important because subjecting all (or a portion) of the DMD micromirror array (also called the active array) to an asymmetric landed duty cycle for a prolonged period of time can reduce the DMD useful life.

Note that it is the symmetry/asymmetry of the landed duty cycle that is of relevance. The symmetry of the landed duty cycle is determined by how close the two numbers (percentages) are to being equal. For example, a landed duty cycle of 50/50 is perfectly symmetrical whereas a landed duty cycle of 100/0 or 0/100 is perfectly asymmetrical.

## 7.7.3 Landed Duty Cycle and Operational DMD Temperature

Operational DMD temperature and landed duty cycle interact to affect DMD useful life, and this interaction can be exploited to reduce the impact that an asymmetrical landed duty cycle has on the DMD useful life. This is quantified in the de-rating curve shown in Figure 1. The importance of this curve is that:

- All points along this curve represent the same useful life.
- All points above this curve represent lower useful life (and the further away from the curve, the lower the
  useful life).
- All points below this curve represent higher useful life (and the further away from the curve, the higher the
  useful life).

In practice, this curve specifies the maximum operating DMD temperature that the DMD should be operated at for a given long-term average landed duty cycle.

#### 7.7.4 Estimating the Long-Term Average Landed Duty Cycle of a Product or Application

During a given period of time, the landed duty cycle of a given pixel follows from the image content being displayed by that pixel.

For example, in the simplest case, when displaying pure-white on a given pixel for a given time period, that pixel operates under a 100/0 landed duty cycle during that time period. Likewise, when displaying pure-black, the pixel operates under a 0/100 landed duty cycle.

Between the two extremes (ignoring for the moment color and any image processing that may be applied to an incoming image), the landed duty cycle tracks one-to-one with the gray scale value, as shown in Table 5.



Table 5. Grayscale Value and Landed Duty Cycle

| GRAYSCALE VALUE | LANDED DUTY CYCLE |
|-----------------|-------------------|
| 0%              | 0/100             |
| 10%             | 10/90             |
| 20%             | 20/80             |
| 30%             | 30/70             |
| 40%             | 40/60             |
| 50%             | 50/50             |
| 60%             | 60/40             |
| 70%             | 70/30             |
| 80%             | 80/20             |
| 90%             | 90/10             |
| 100%            | 100/0             |

Accounting for color rendition (but still ignoring image processing) requires knowing both the color intensity (from 0% to 100%) for each constituent primary color (red, green, and/or blue) for the given pixel as well as the color cycle time for each primary color, where "color cycle time" is the total percentage of the frame time that a given primary must be displayed in order to achieve the desired white point.

Use Equation 1 to calculate the landed duty cycle of a given pixel during a given time period

Landed Duty Cycle = (Red\_Cycle\_% × Red\_Scale\_Value) + (Green\_Cycle\_% × Green\_Scale\_Value) + (Blue\_Cycle\_% × Blue\_Scale\_Value)

#### where

- Red\_Cycle\_%, represents the percentage of the frame time that red is displayed to achieve the desired white point
- Green\_Cycle\_% represents the percentage of the frame time that green is displayed to achieve the desired white point
- Blue\_Cycle\_%, represents the percentage of the frame time that blue is displayed to achieve the desired white
  point (1)

For example, assume that the red, green, and blue color cycle times are 50%, 20%, and 30% respectively (in order to achieve the desired white point), then the landed duty cycle for various combinations of red, green, blue color intensities would be as shown in Table 6 and Table 7.

Table 6. Example Landed Duty Cycle for Full-Color, Color Percentage

| CYCLE PERCENTAGE |           |     |  |  |  |
|------------------|-----------|-----|--|--|--|
| RED              | RED GREEN |     |  |  |  |
| 50%              | 20%       | 30% |  |  |  |



Table 7. Example Landed Duty Cycle for Full-Color

| SCALE VALUE |       |      | LANDED DUTY |  |  |
|-------------|-------|------|-------------|--|--|
| RED         | GREEN | BLUE | CYCLE       |  |  |
| 0%          | 0%    | 0%   | 0/100       |  |  |
| 100%        | 0%    | 0%   | 50/50       |  |  |
| 0%          | 100%  | 0%   | 20/80       |  |  |
| 0%          | 0%    | 100% | 30/70       |  |  |
| 12%         | 0%    | 0%   | 6/94        |  |  |
| 0%          | 35%   | 0%   | 7/93        |  |  |
| 0%          | 0%    | 60%  | 18/82       |  |  |
| 100%        | 100%  | 0%   | 70/30       |  |  |
| 0%          | 100%  | 100% | 50/50       |  |  |
| 100%        | 0%    | 100% | 80/20       |  |  |
| 12%         | 35%   | 0%   | 13/87       |  |  |
| 0%          | 35%   | 60%  | 25/75       |  |  |
| 12%         | 0%    | 60%  | 24/76       |  |  |
| 100%        | 100%  | 100% | 100/0       |  |  |

The last factor to account for in estimating the landed duty cycle is any applied image processing. Within the DLPC6421 controllers, the gamma function affects the landed duty cycle.

Gamma is a power function of the form  $Output\_Level = A \times Input\_Level^{Gamma}$ , where A is a scaling factor that is typically set to 1.

In the DLPC6421 controllers, gamma is applied to the incoming image data on a pixel-by-pixel basis. A typical gamma factor is 2.2, which transforms the incoming data as shown in Figure 11.

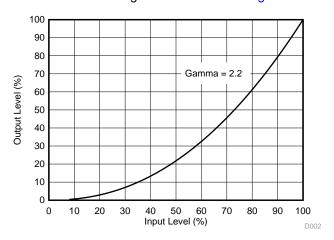


Figure 11. Example of Gamma = 2.2

From Figure 11, if the gray scale value of a given input pixel is 40% (before gamma is applied), then gray scale value will be 13% after gamma is applied. Therefore, it can be seen that since gamma has a direct impact displayed gray scale level of a pixel, it also has a direct impact on the landed duty cycle of a pixel.

Consideration must also be given to any image processing which occurs before the DLPC3439 controllers.



## 8 Application and Implementation

#### NOTE

Information in the following application sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

Texas Instruments DLP technology is a micro-electro-mechanical systems (MEMS) technology that modulates light using a digital micromirror device (DMD). The DMD is a spatial light modulator, which reflects incoming light from an illumination source to one of two directions, towards the projection optics or collection optics. The new TRP pixel with a higher tilt angle increases brightness performance and enables smaller system electronics for size constrained applications. Typical applications using the DLP470TP include home cinema, digital signage, smart home/appliances, low-latency gaming display, and mobile smart TV.

The most recent class of chipsets from Texas Instruments is based on a breakthrough micromirror technology, called TRP. With a smaller pixel pitch of  $5.4~\mu m$  and increased tilt angle of 17 degrees, TRP chipsets enable higher resolution in a smaller form factor and enhanced image processing features while maintaining high optical efficiency. DLP chipsets are a great fit for any system that requires high resolution and high brightness displays.

## 8.2 Typical Application

The DLP470TP DMD combined with two DLPC6421 digital controllers and a power management device provides full 4K UHD resolution for bright, colorful display applications. See Figure 12, a block diagram showing the system components needed along with the LED configuration of the DLP 0.47" 4K UHD chipset. The components include the DLP470TP DMD, two DLPC6421 display controllers and the DLPA3005 PMIC and LED driver.

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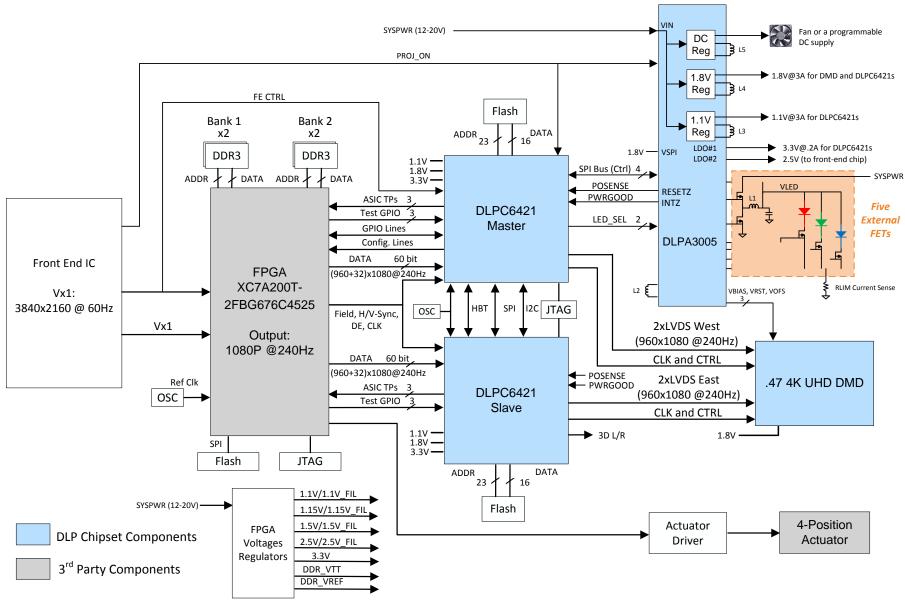


Figure 12. Typical 4K UHD LED Application Diagram



#### 8.2.1 Design Requirements

Other core components of the display system include an illumination source, an optical engine for the illumination and projection optics, other electrical and mechanical components, and software. The type of illumination used and desired brightness will have a major effect on the overall system design and size.

The DLP470TP is used as the core imaging device in the display system and contains a 0.47-inch array of micromirrors. The DLPC6421 controller is the digital interface between the DMD and the rest of the system, taking digital input from front end receiver and driving the DMD over a high speed interface. The DLPA3005 PMIC serves as a voltage regulator for the DMD, controller, and LED illumination functionality.

#### 8.2.2 Detailed Design Procedure

For a complete DLP system, an optical module or light engine is required that contains the DLP470TP DMD, associated illumination sources, optical elements, and necessary mechanical components.

To ensure reliable operation, the DLP470TP DMD must always be used with two DLPC6421 display controllers and the DLPA3005 PMIC and LED driver. Refer to PCB Design Requirements for TI DLP Pico TRP Digital Micromirror Devices for the DMD board design and manufacturing handling of the DMD sub assemblies.

#### 8.2.3 Application Curves

The typical LED-current-to-luminance relationship when LED illumination is utilized is shown in Figure 13.

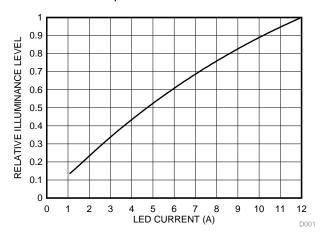


Figure 13. Luminance vs. Current



## 9 Power Supply Recommendations

The following power supplies are all required to operate the DMD:

- V<sub>SS</sub>
- V<sub>BIAS</sub>
- V<sub>CC</sub>
- V<sub>OFFSET</sub>
- V<sub>RESET</sub>

DMD power-up and power-down sequencing is strictly controlled by the DLP display controller.

#### CAUTION

For reliable operation of the DMD, the following power supply sequencing requirements must be followed. Failure to adhere to any of the prescribed power-up and power-down requirements may affect device reliability. See the DMD power supply sequencing requirements in Figure 14.

 $V_{\text{BIAS}}$ ,  $V_{\text{CC}}$ ,  $V_{\text{OFFSET}}$ , and  $V_{\text{RESET}}$  power supplies must be coordinated during power-up and power-down operations. Failure to meet any of the below requirements will result in a significant reduction in the DMD reliability and lifetime. Common ground  $V_{\text{SS}}$  must also be connected.

#### 9.1 DMD Power Supply Power-Up Procedure

- During power-up, V<sub>CC</sub> must always start and settle before V<sub>OFFSET</sub> plus Delay1 specified in Table 8, V<sub>BIAS</sub>, and V<sub>RESET</sub> voltages are applied to the DMD.
- During power-up, it is a strict requirement that the voltage difference between V<sub>BIAS</sub> and V<sub>OFFSET</sub> must be within the specified limit shown in Recommended Operating Conditions.
- During power-up, there is no requirement for the relative timing of V<sub>RESET</sub> with respect to V<sub>BIAS</sub>.
- Power supply slew rates during power-up are flexible, provided that the transient voltage levels follow the requirements specified in *Absolute Maximum Ratings*, in *Recommended Operating Conditions*, and in Figure 14.
- During power-up, LVCMOS input pins must not be driven high until after V<sub>CC</sub> have settled at operating voltages listed in Recommended Operating Conditions.

## 9.2 DMD Power Supply Power-Down Procedure

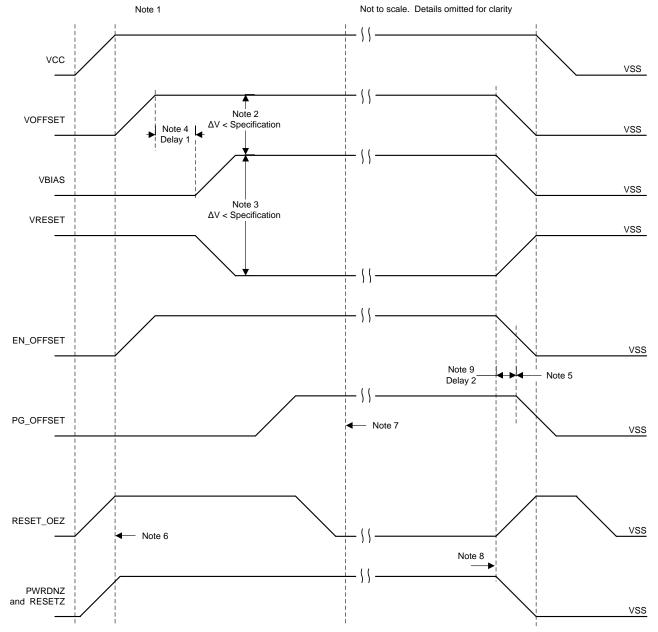
- During power-down, V<sub>CC</sub> must be supplied until after V<sub>BIAS</sub>, V<sub>RESET</sub>, and V<sub>OFFSET</sub> are discharged to within the specified limit of ground. See Table 8.
- During power-down, it is a strict requirement that the voltage difference between V<sub>BIAS</sub> and V<sub>OFFSET</sub> must be within the specified limit shown in *Recommended Operating Conditions*.
- During power-down, there is no requirement for the relative timing of V<sub>RESET</sub> with respect to V<sub>BIAS</sub>.
- Power supply slew rates during power-down are flexible, provided that the transient voltage levels follow the requirements specified in *Absolute Maximum Ratings*, in *Recommended Operating Conditions*, and in Figure 14.
- During power-down, LVCMOS input pins must be less than specified in Recommended Operating Conditions.

## **Table 8. DMD Power-Supply Requirements**

| PARAMETER             | DESCRIPTION  | MIN | NOM | MAX | UNIT |
|-----------------------|--|-----|-----|-----|------|
| Delay1 (1)            | Delay from $V_{\text{OFFSET}}$ settled at recommended operating voltage to $V_{\text{BIAS}}$ and $V_{\text{RESET}}$ power up | 1   | 2   |     | ms   |
| Delay2 <sup>(1)</sup> | PG_OFFSET hold time after EN_OFFSET goes low   | 100 |     |     | ns   |

(1) See Figure 14.





- (1) See Recommended Operating Conditions and the pin functions table.
- (2) To prevent excess current, the supply voltage difference |V<sub>OFFSET</sub> V<sub>BIAS</sub>| must be less than the specified limit in *Recommended Operating Conditions*.
- (3) To prevent excess current, the supply difference |V<sub>BIAS</sub> V<sub>RESET</sub>| must be less than the specified limit in the *Recommended Operating Conditions*.
- (4) V<sub>BIAS</sub> should power up after V<sub>OFFSET</sub> has powered up, per the Delay1 specification in Table 8.
- (5) PG\_OFFSET should turn off after EN\_OFFSET has turned off, per the Delay2 specification in Table 8.
- (6) DLP controller software enables the DMD power supplies to turn on after RESET\_OEZ is at logic high.
- (7) DLP controller software initiates the global V<sub>BIAS</sub> command.
- (8) After the DMD micromirror park sequence is complete, the DLP controller software initiates a hardware power-down that activates PWRDNZ and disables V<sub>BIAS</sub>, V<sub>RESET</sub> and V<sub>OFFSET</sub>.
- (9) Under power-loss conditions where emergency DMD micromirror park procedures are being enacted by the DLP controller hardware, EN\_OFFSET may turn off after PG\_OFFSET has turned off. The OEZ signal goes high prior to PG\_OFFSET turning off to indicate the DMD micromirror has completed the emergency park procedures.

#### Figure 14. DMD Power Supply Requirements

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# 10 Layout

## 10.1 Layout Guidelines

The DLP470TP DMD is part of a chipset that is controlled by two DLPC6421 display controllers in conjunction with the DLPA3005 PMIC and LED driver. These guidelines are targeted at designing a PCB board with the DLP470TP DMD. The DLP470TP DMD board is a high-speed multi-layer PCB, with primarily high-speed digital logic utilizing dual edge clock rates up to 400 MHz for DMD LVDS signals. The remaining traces are comprised of low speed digital LVTTL signals. TI recommends that mini power planes are used for  $V_{OFFSET}$ ,  $V_{RESET}$ , and  $V_{BIAS}$ . Solid planes are required for ground ( $V_{SS}$ ). The target impedance for the PCB is 50  $\Omega$  ±10% with the LVDS traces being 100  $\Omega$  ±10% differential. TI recommends using an 8 layer stack-up as described in Table 9.

## 10.2 Layout Example

#### 10.2.1 Layers

The layer stack-up and copper weight for each layer is shown in Table 9. Small sub-planes are allowed on signal routing layers to connect components to major sub-planes on top/bottom layers if necessary.

**LAYER** COPPER WT. LAYER NAME **COMMENTS** (oz.) NO. Side A - DMD only DMD, escapes, low frequency signals, power sub-planes 1.5 2 Ground 0.5 Solid ground plane (net GND) 3 Signal 0.5 50  $\Omega$  and 100  $\Omega$  differential signals 4 Signal/Power 0.5 50  $\Omega$  and 100  $\Omega$  differential signals / power Solid ground plane (net GND) Ground 0.5 50  $\Omega$  and 100  $\Omega$  differential signals 6 Signal 0.5 7 Ground 0.5 Solid ground plane (net GND) Side B - All other Components 1.5 Discrete components, low frequency signals, power sub-planes

Table 9. Layer Stack-Up

#### 10.2.2 Impedance Requirements

TI recommends that the board has a matched impedance of 50  $\Omega$  ±10% for all signals. The exceptions are listed in Table 10.

| Signal Type                                    | Signal Name            | Impedance (ohms)                       |  |
|--|------------------------|--|--|
| A, B, C, and D channel LVDS differential pairs | DDxP(0:15), DDxN(0:15) |  |  |
|  | DCLKx_P, DCLKx_N       | 100 ±10% differential across each pair |  |
|  | SCTRL_CP, SCTRL_CN     | - cacii paii                           |  |

**Table 10. Special Impedance Requirements** 

## 10.2.3 Trace Width, Spacing

Unless otherwise specified, TI recommends that all signals follow the 0.005"/0.005" design rule. Minimum trace clearance from the ground ring around the PWB has a 0.1" minimum. An analysis of impedance and stack-up requirements determine the actual trace widths and clearances.



# 10.2.3.1 Voltage Signals

# Table 11. Special Trace Widths, Spacing Requirements

| SIGNAL NAME         | MINIMUM TRACE WIDTH TO<br>PINS (MIL) | LAYOUT REQUIREMENT                     |  |  |  |  |  |
|---------------------|--------------------------------------|--|--|--|--|--|--|
| $V_{SS}$            | 15                                   | Maximize trace width to connecting pin |  |  |  |  |  |
| V <sub>CC</sub>     | 15                                   | Maximize trace width to connecting pin |  |  |  |  |  |
| V <sub>OFFSET</sub> | 15                                   | Create mini plane to DMD               |  |  |  |  |  |
| V <sub>RESET</sub>  | 15                                   | Create mini plane to DMD               |  |  |  |  |  |
| $V_{BIAS}$          | 15                                   | Create mini plane to DMD               |  |  |  |  |  |



## 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Device Nomenclature

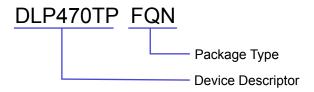


Figure 15. Part Number Description

### 11.1.2 Device Markings

The device marking includes both human-readable information and a 2-dimensional matrix code. The human-readable information is described in Figure 16 and includes the legible character string GHJJJJK 1910-50BBM. GHJJJJK is the lot trace code and 1910-50BBM is the device marking.

Example: GHJJJJK 1910-50BBM

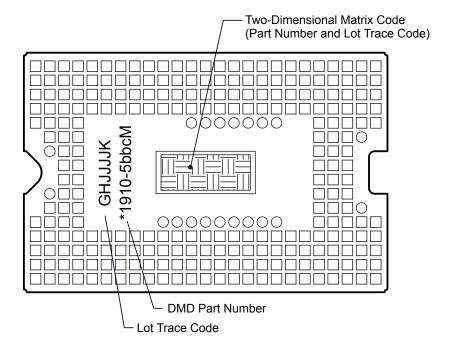


Figure 16. DMD Marking Locations



## 11.2 Documentation Support

#### 11.2.1 Related Documentation

The following documents contain additional information related to the chipset components used with the DLP470TP.

- DLPC6421 Display Controller Data Sheet
- DLPA3005 PMIC/LED Driver Data Sheet

### 11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.4 Community Resources

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**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.5 Trademarks

Pico, E2E are trademarks of Texas Instruments. DLP is a registered trademark of Texas Instruments.

#### 11.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



# PACKAGE OPTION ADDENDUM

2-Jun-2018

#### PACKAGING INFORMATION

| Orderable Device | Status | Package Type | _       | Pins | _   | Eco Plan     | Lead/Ball Finish | MSL Peak Temp      | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|---------|------|-----|--------------|------------------|--------------------|--------------|----------------|---------|
|                  | (1)    |              | Drawing |      | Qty | (2)          | (6)              | (3)                |              | (4/5)          |         |
| DLP470TPFQN      | ACTIVE | CLGA         | FQN     | 250  | 54  | RoHS & Green | Call TI          | N / A for Pkg Type |              |                | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

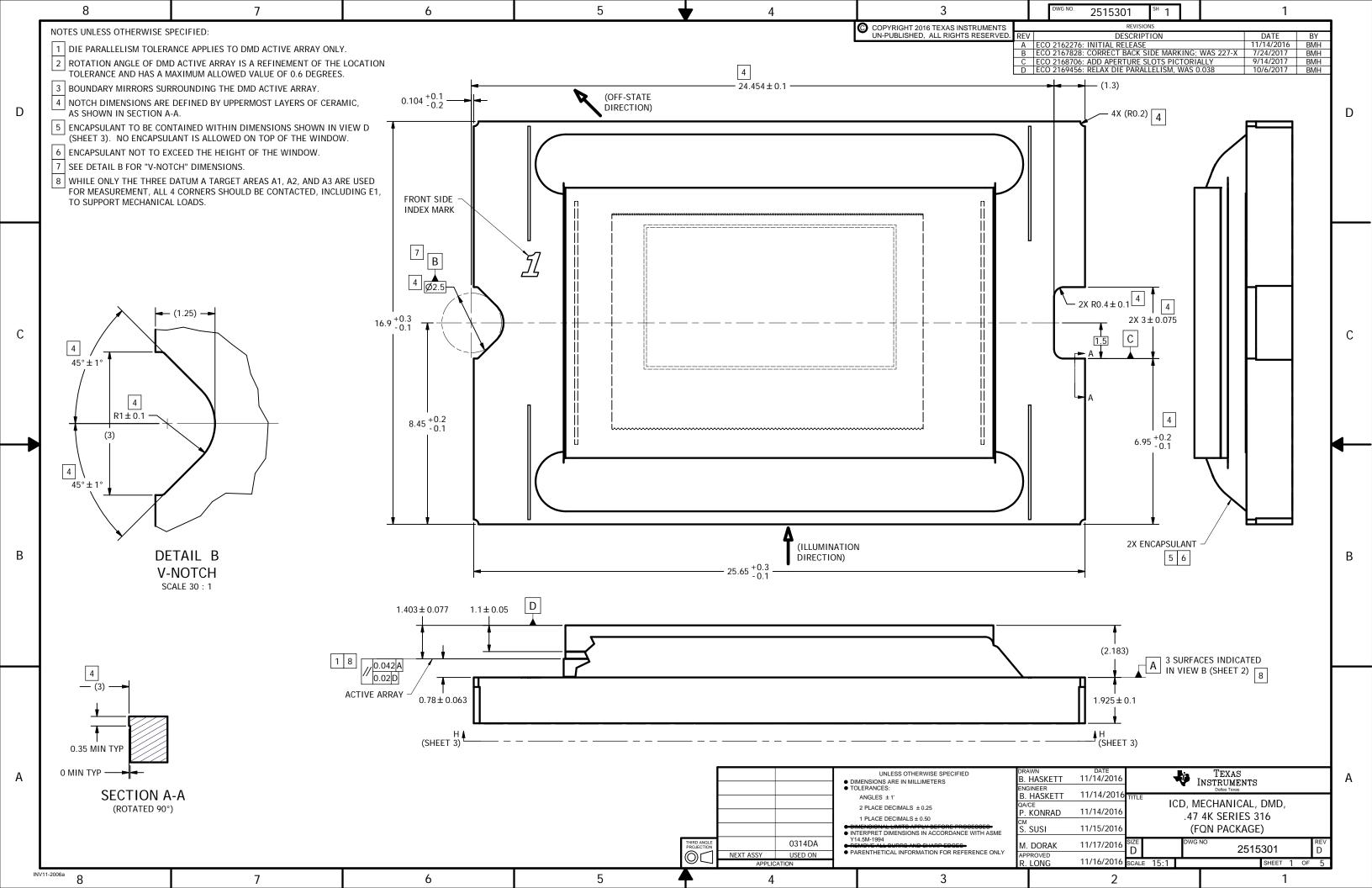
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

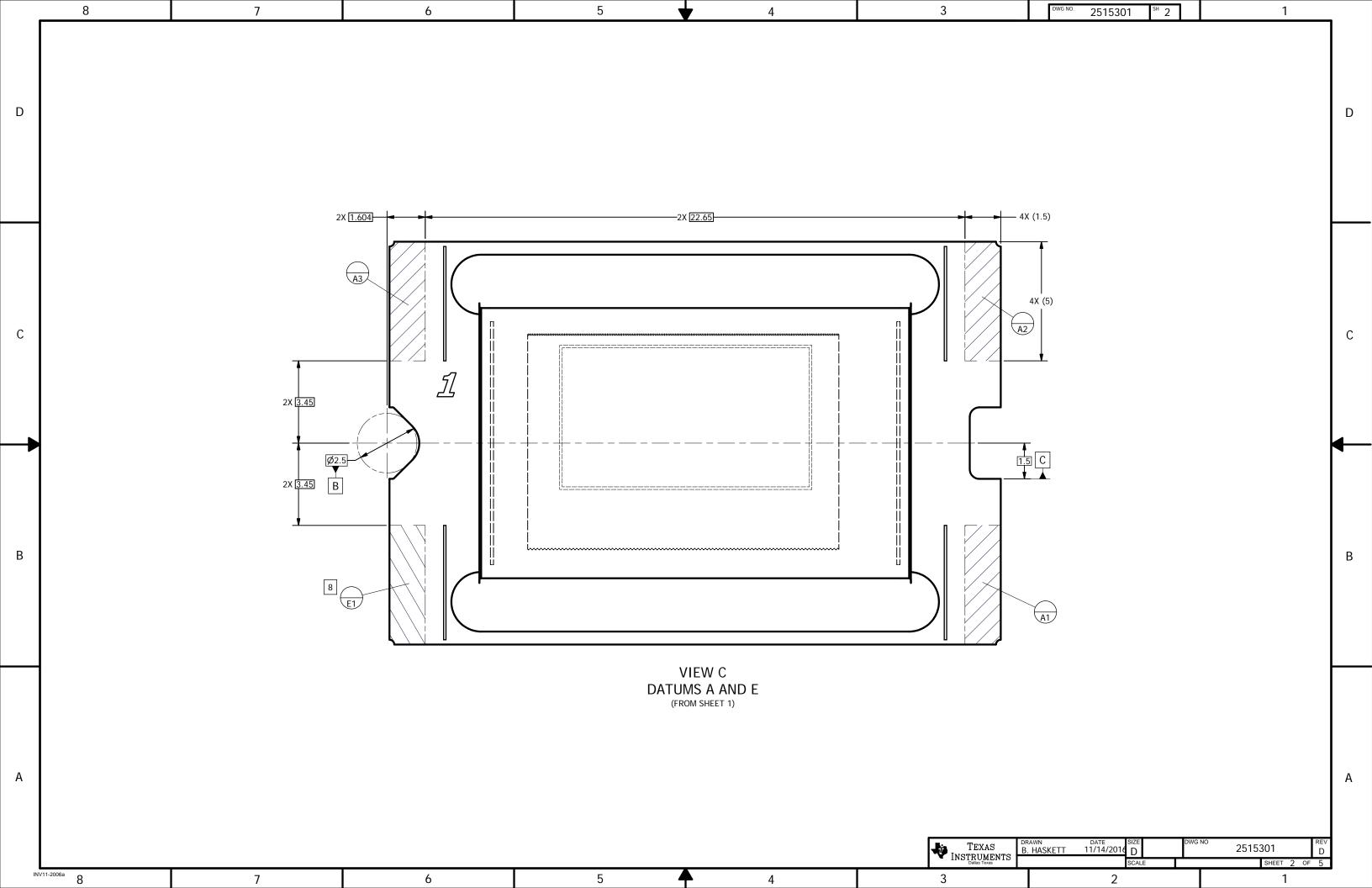
**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

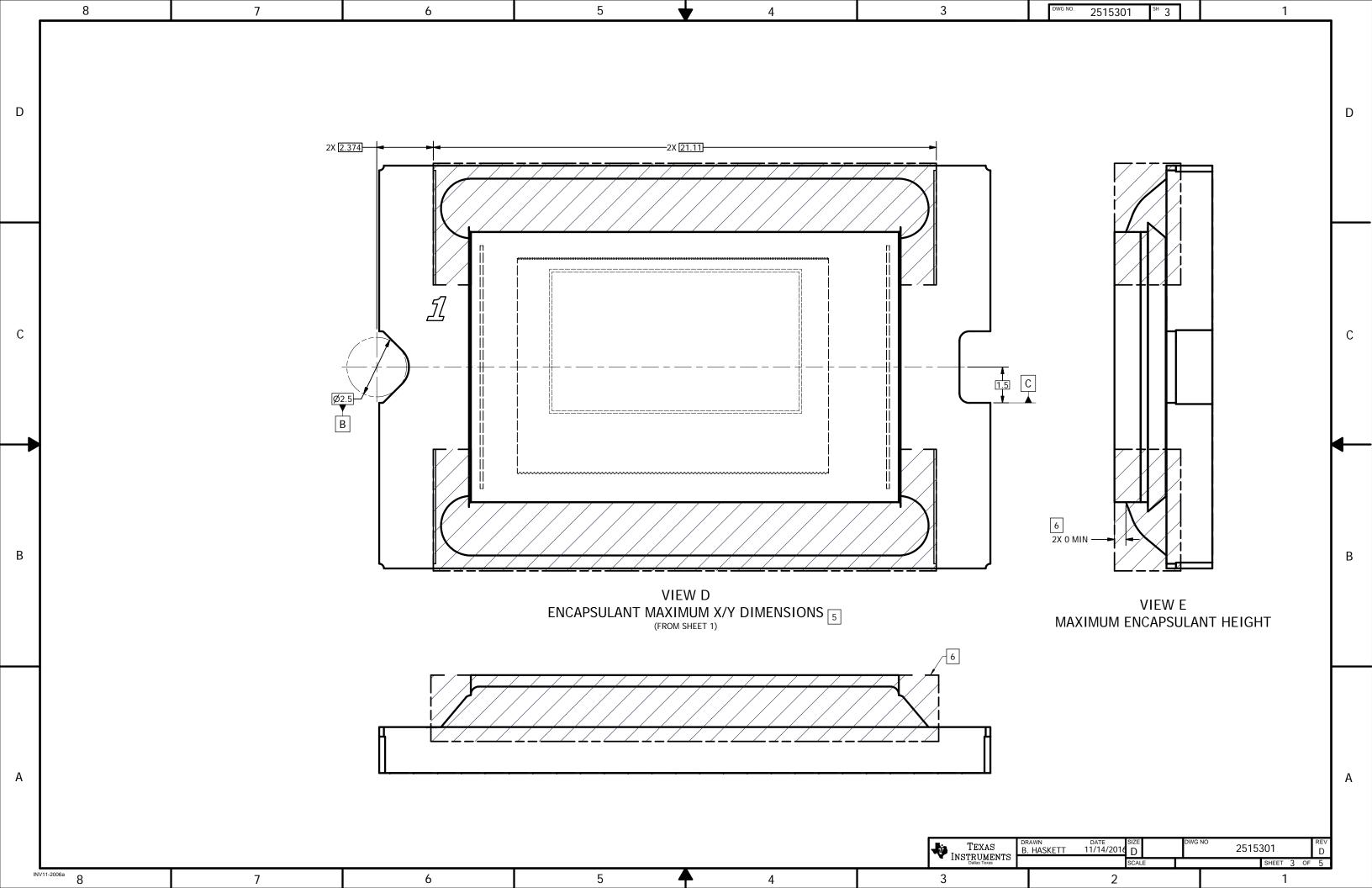
- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

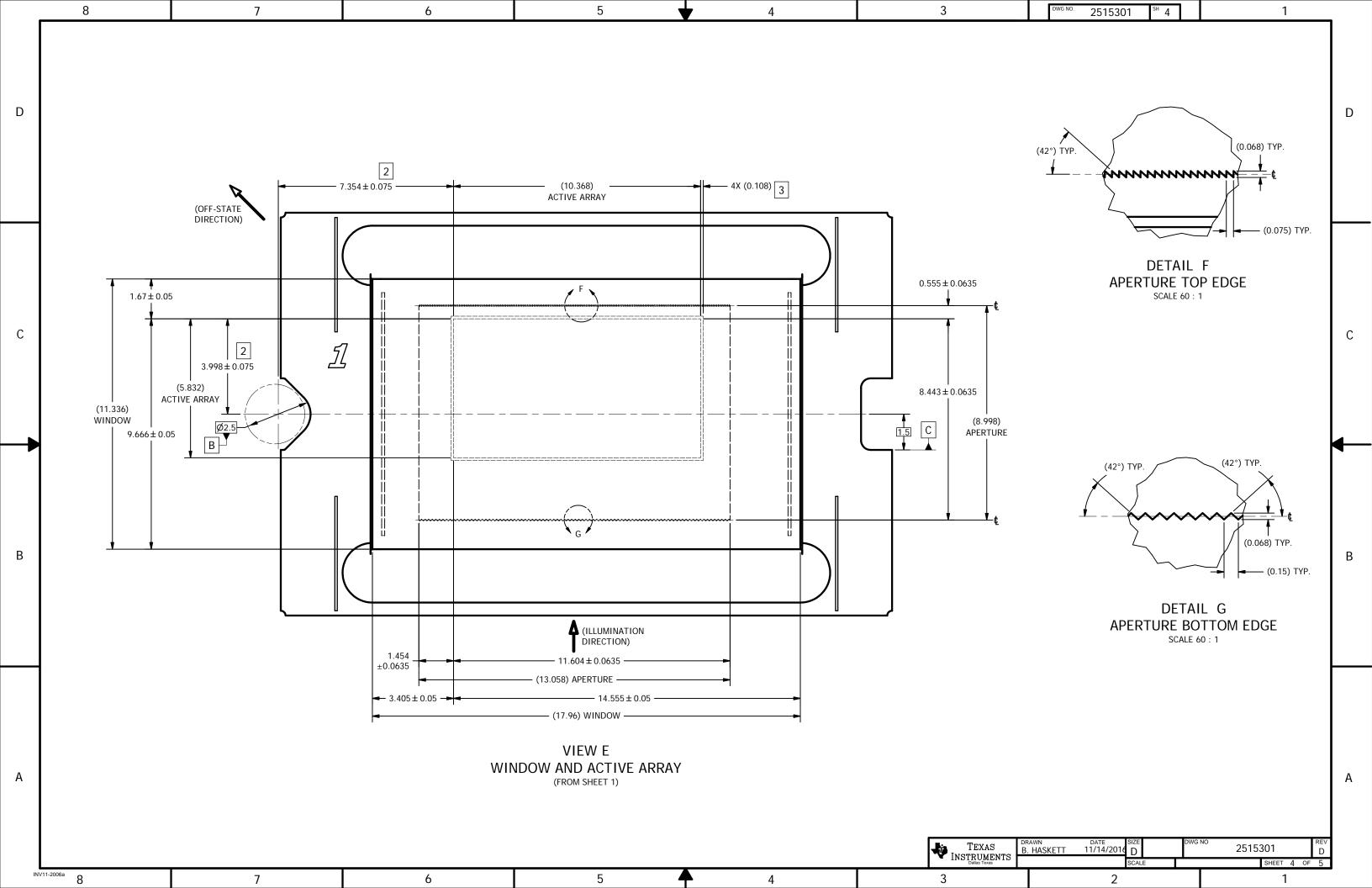
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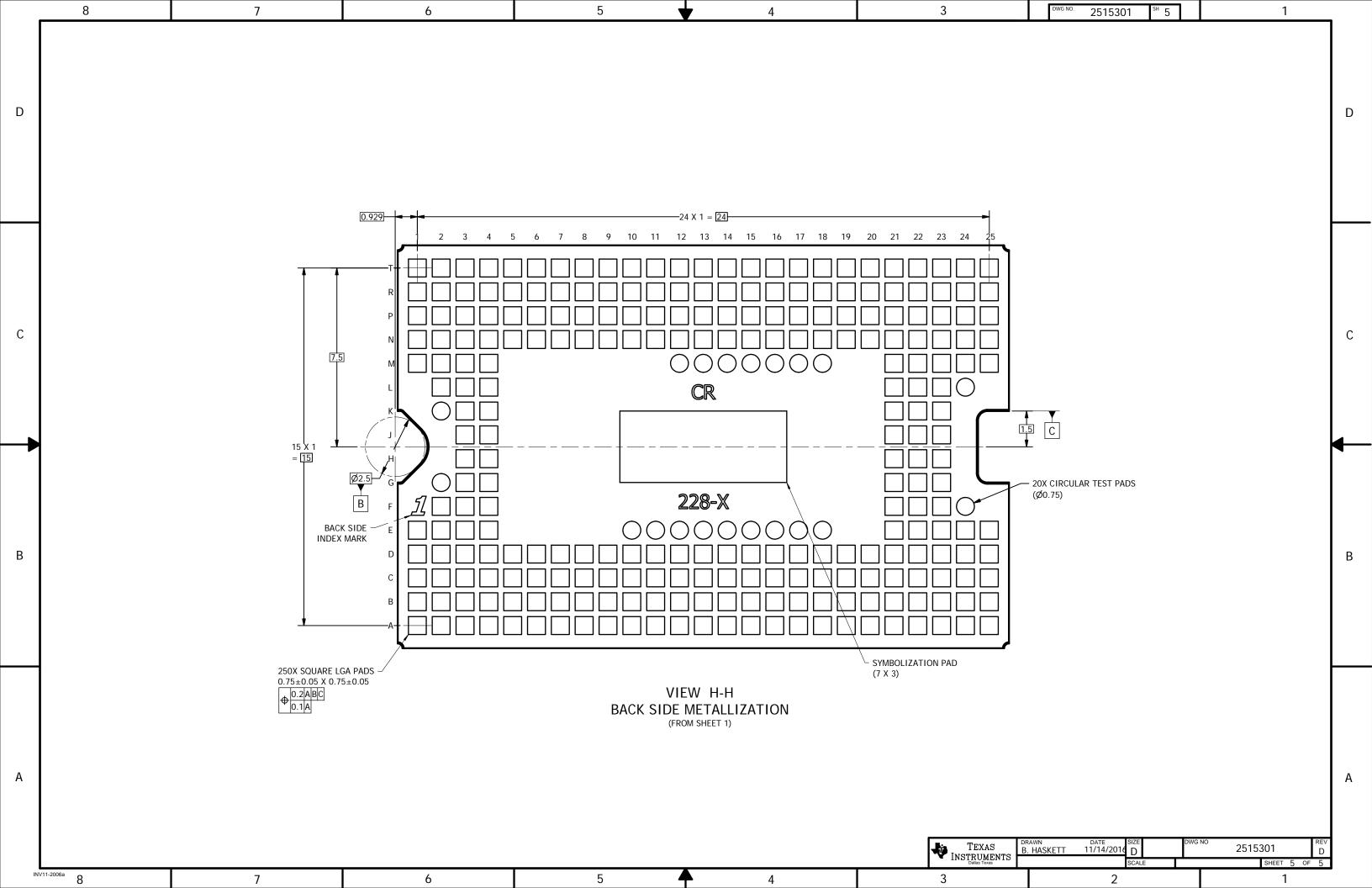
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